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# PSoC® 4: PSoC 4000S Datasheet Programmable System-on-Chip (PSoC®)

# **General Description**

PSoC<sup>®</sup> 4 is a scalable and reconfigurable platform architecture for a family of programmable embedded system controllers with an Arm<sup>®</sup> Cortex<sup>®</sup>-M0+ CPU. It combines programmable and reconfigurable analog and digital blocks with flexible automatic routing. The PSoC 4000S product family is a member of the PSoC 4 platform architecture. It is a combination of a microcontroller with standard communication and timing peripherals, a capacitive touch-sensing system (CapSense) with best-in-class performance, programmable general-purpose continuous-time and switched-capacitor analog blocks, and programmable connectivity. PSoC 4000S products will be upward compatible with members of the PSoC 4 platform for new applications and design needs.

#### **Features**

# 32-bit MCU Subsystem

- 48-MHz Arm Cortex-M0+ CPU with single-cycle multiply
- Up to 32 KB of flash with Read Accelerator
- Up to 4 KB of SRAM

# **Programmable Analog**

- Single-slope 10-bit ADC function provided by Capacitance sensing block
- Two current DACs (IDACs) for general-purpose or capacitive sensing applications on any pin
- Two low-power comparators that operate in Deep Sleep low-power mode

#### **Programmable Digital**

Programmable logic blocks allowing Boolean operations to be performed on port inputs and outputs

#### Low-Power 1.71-V to 5.5-V Operation

Deep Sleep mode with operational analog and 2.5 μA digital system current

#### **Capacitive Sensing**

- Cypress CapSense Sigma-Delta (CSD) provides best-in-class signal-to-noise ratio (SNR) (>5:1) and water tolerance
- Cypress-supplied software component makes capacitive sensing design easy
- Automatic hardware tuning (SmartSense™)

### **Serial Communication**

Two independent run-time reconfigurable Serial Communication Blocks (SCBs) with re-configurable I2C, SPI, or UART functionality

#### LCD Drive Capability

■ LCD segment drive capability on GPIOs

#### Timing and Pulse-Width Modulation

- Five 16-bit timer/counter/pulse-width modulator (TCPWM) blocks
- Center-aligned, Edge, and Pseudo-random modes
- Comparator-based triggering of Kill signals for motor drive and other high-reliability digital logic applications

#### Up to 36 Programmable GPIO Pins

- 48-pin TQFP, 40-pin QFN, 32-pin QFN, 24-pin QFN, 32-pin TQFP, and 25-ball WLCSP packages
- Any GPIO pin can be CapSense, analog, or digital
- Drive modes, strengths, and slew rates are programmable

#### **PSoC Creator Design Environment**

- Integrated Development Environment (IDE) provides schematic design entry and build (with analog and digital automatic routing)
- Applications Programming Interface (API) component for all fixed-function and programmable peripherals

#### **Industry-Standard Tool Compatibility**

 After schematic entry, development can be done with Arm-based industry-standard development tools

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# Logic Block Diagram

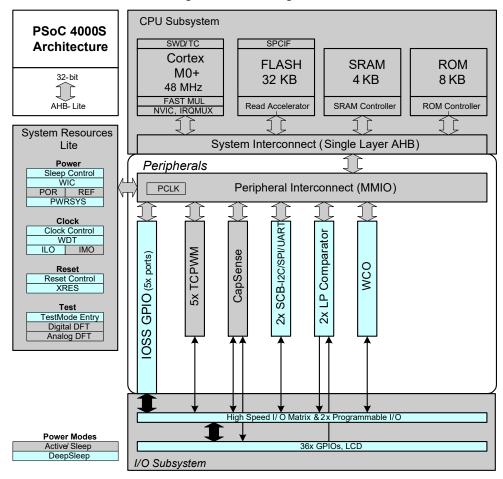


Figure 1. Block Diagram

# **Functional Description**

PSoC 4000S devices include extensive support for programming, testing, debugging, and tracing both hardware and firmware.

The ARM Serial-Wire Debug (SWD) interface supports all programming and debug features of the device.

Complete debug-on-chip functionality enables full-device debugging in the final system using the standard production device. It does not require special interfaces, debugging pods, simulators, or emulators. Only the standard programming connections are required to fully support debug.

The PSoC Creator IDE provides fully integrated programming and debug support for the PSoC 4000S devices. The SWD interface is fully compatible with industry-standard third-party tools. The PSoC 4000S family provides a level of security not possible with multi-chip application solutions or with microcontrollers. It has the following advantages:

- Allows disabling of debug features
- Robust flash protection

 Allows customer-proprietary functionality to be implemented in on-chip programmable blocks

The debug circuits are enabled by default and can be disabled in firmware. If they are not enabled, the only way to re-enable them is to erase the entire device, clear flash protection, and reprogram the device with new firmware that enables debugging. Thus firmware control of debugging cannot be over-ridden without erasing the firmware thus providing security.

Additionally, all device interfaces can be permanently disabled (device security) for applications concerned about phishing attacks due to a maliciously reprogrammed device or attempts to defeat security by starting and interrupting flash programming sequences. All programming, debug, and test interfaces are disabled when maximum device security is enabled. Therefore, PSoC 4000S, with device security enabled, may not be returned for failure analysis. This is a trade-off the PSoC 4000S allows the customer to make.



#### More Information

Cypress provides a wealth of data at www.cypress.com to help you to select the right PSoC device for your design, and to help you to quickly and effectively integrate the device into your design. For a comprehensive list of resources, see the knowledge base article KBA86521, How to Design with PSoC 3, PSoC 4, and PSoC 5LP. Following is an abbreviated list for PSoC 4:

- Overview: PSoC Portfolio, PSoC Roadmap
- Product Selectors: PSoC 1, PSoC 3, PSoC 4, PSoC 5LP In addition, PSoC Creator includes a device selection tool.
- Application notes: Cypress offers a large number of PSoC application notes covering a broad range of topics, from basic to advanced level. Recommended application notes for getting started with PSoC 4 are:
  - □ AN79953: Getting Started With PSoC 4
  - □ AN88619: PSoC 4 Hardware Design Considerations
  - □ AN86439: Using PSoC 4 GPIO Pins
  - □ AN57821: Mixed Signal Circuit Board Layout
  - □ AN81623: Digital Design Best Practices
  - □ AN73854: Introduction To Bootloaders
  - □ AN89610: Arm Cortex Code Optimization
  - ☐ AN85951: PSoC® 4 and PSoC 6 MCU CapSense® Design
- Technical Reference Manual (TRM) is in two documents:
  - ☐ Architecture TRM details each PSoC 4 functional block.
  - □ Registers TRM describes each of the PSoC 4 registers.
- Development Kits:
  - □ CY8CKIT-041-40XX PSoC 4 S-Series Pioneer Kit is an easy-to-use and inexpensive development platform. This kit includes connectors for Arduino™ compatible shields.
  - □ CY8CKIT-145 PSoC 4000S CapSense Prototyping Kit enables you to evaluate and develop with Cypress' fourth-generation, low power CapSense solution using the PSoC 4000s device.

The MiniProg3 device provides an interface for flash programming and debug.

#### ■ Software User Guide:

□ A step-by-step guide for using PSoC Creator. The software user guide shows you how the PSoC Creator build process works in detail, how to use source control with PSoC Creator, and much more.

#### ■ Component Datasheets:

□ The flexibility of PSoC allows the creation of new peripherals (components) long after the device has gone into production. Component datasheets provide all the information needed to select and use a particular component, including a functional description, API documentation, example code, and AC/DC specifications.

#### ■ Online:

☐ In addition to print documentation, the Cypress PSoC forums connect you with fellow PSoC users and experts in PSoC from around the world, 24 hours a day, 7 days a week.

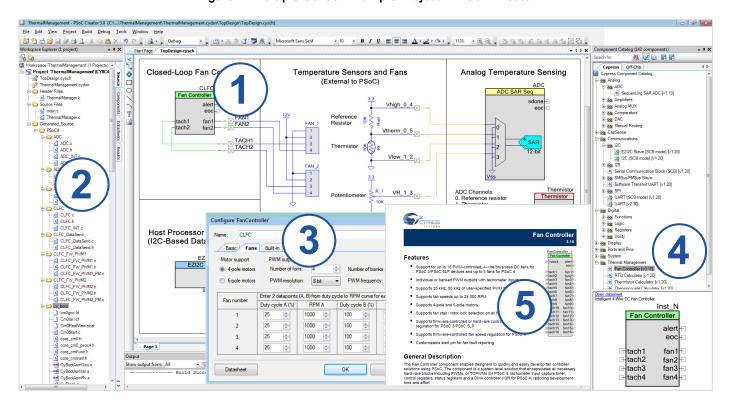


# **PSoC Creator**

PSoC Creator is a free Windows-based Integrated Design Environment (IDE). It enables concurrent hardware and firmware design of PSoC 3, PSoC 4, and PSoC 5LP based systems. Create designs using classic, familiar schematic capture supported by over 100 pre-verified, production-ready PSoC Components; see the list of component datasheets. With PSoC Creator, you can:

- 1. Drag and drop component icons to build your hardware system design in the main design workspace
- Codesign your application firmware with the PSoC hardware, using the PSoC Creator IDE C compiler
- 3. Configure components using the configuration tools
- 4. Explore the library of 100+ components
- 5. Review component datasheets

Figure 2. Multiple-Sensor Example Project in PSoC Creator





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# **Functional Overview**

# CPU and Memory Subsystem

#### CPU

The Cortex-M0+ CPU in the PSoC 4000S is part of the 32-bit MCU subsystem, which is optimized for low-power operation with extensive clock gating. Most instructions are 16 bits in length and the CPU executes a subset of the Thumb-2 instruction set. It includes a nested vectored interrupt controller (NVIC) block with eight interrupt inputs and also includes a Wakeup Interrupt Controller (WIC). The WIC can wake the processor from Deep Sleep mode, allowing power to be switched off to the main processor when the chip is in Deep Sleep mode.

The CPU also includes a debug interface, the serial wire debug (SWD) interface, which is a two-wire form of JTAG. The debug configuration used for PSoC 4000S has four breakpoint (address) comparators and two watchpoint (data) comparators.

#### Flash

The PSoC 4000S device has a flash module with a flash accelerator, tightly coupled to the CPU to improve average access times from the flash block. The low-power flash block is designed to deliver two wait-state (WS) access time at 48 MHz. The flash accelerator delivers 85% of single-cycle SRAM access performance on average.

#### **SRAM**

Four KB of SRAM are provided with zero wait-state access at 48 MHz.

#### **SROM**

A supervisory ROM that contains boot and configuration routines is provided.

#### System Resources

#### Power System

The power system is described in detail in the section Power on page 12. It provides assurance that voltage levels are as required for each respective mode and either delays mode entry (for example, on power-on reset (POR)) until voltage levels are as required for proper functionality, or generates resets (for example, on brown-out detection). The PSoC 4000S operates with a single external supply over the range of either 1.8 V  $\pm 5\%$  (externally regulated) or 1.8 to 5.5 V (internally regulated) and has three different power modes, transitions between which are managed by the power system. The PSoC 4000S provides Active, Sleep, and Deep Sleep low-power modes.

All subsystems are operational in Active mode. The CPU subsystem (CPU, flash, and SRAM) is clock-gated off in Sleep mode, while all peripherals and interrupts are active with instantaneous wake-up on a wake-up event. In Deep Sleep mode, the high-speed clock and associated circuitry is switched off; wake-up from this mode takes 35 µs.

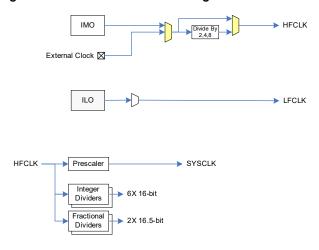
#### Clock System

The PSoC 4000S clock system is responsible for providing clocks to all subsystems that require clocks and for switching between different clock sources without glitching. In addition, the clock system ensures that there are no metastable conditions.

The clock system for the PSoC 4000S consists of the internal main oscillator (IMO), internal low-frequency oscillator (ILO), a 32 kHz Watch Crystal Oscillator (WCO) and provision for an external clock. Clock dividers are provided to generate clocks for peripherals on a fine-grained basis. Fractional dividers are also provided to enable clocking of higher data rates for UARTs.

The HFCLK signal can be divided down to generate synchronous clocks for the analog and digital peripherals. There are eight clock dividers for the PSoC 4000S, two of those are fractional dividers. The 16-bit capability allows flexible generation of fine-grained frequency values, and is fully supported in PSoC Creator.

Figure 3. PSoC 4000S MCU Clocking Architecture



# IMO Clock Source

The IMO is the primary source of internal clocking in the PSoC 4000S. It is trimmed during testing to achieve the specified accuracy. The IMO default frequency is 24 MHz and it can be adjusted from 24 to 48 MHz in steps of 4 MHz. The IMO tolerance with Cypress-provided calibration settings is ±2%.

#### **ILO Clock Source**

The ILO is a very low power, nominally 40-kHz oscillator, which is primarily used to generate clocks for the watchdog timer (WDT) and peripheral operation in Deep Sleep mode. ILO-driven counters can be calibrated to the IMO to improve accuracy. Cypress provides a software component, which does the calibration.

# Watch Crystal Oscillator (WCO)

The PSoC 4000S clock subsystem also implements a low-frequency (32-kHz watch crystal) oscillator that can be used for precision timing applications. The WCO block allows locking the IMO to the 32-kHz oscillator. The WCO on PSoC 4000S series devices does not connect to the LFCLK or WDT. Due to this, RTC functionality is not supported.



#### Watchdog Timer

A watchdog timer is implemented in the clock block running from the ILO; this allows watchdog operation during Deep Sleep and generates a watchdog reset if not serviced before the set timeout occurs. The watchdog reset is recorded in a Reset Cause register, which is firmware readable.

#### Reset

The PSoC 4000S can be reset from a variety of sources including a software reset. Reset events are asynchronous and guarantee reversion to a known state. The reset cause is recorded in a register, which is sticky through reset and allows software to determine the cause of the reset. An XRES pin is reserved for external reset by asserting it active low. The XRES pin has an internal pull-up resistor that is always enabled.

#### Voltage Reference

The PSoC 4000S reference system generates all internally required references. A 1.2-V voltage reference is provided for the comparator. The IDACs are based on a ±5% reference.

#### **Analog Blocks**

#### Low-power Comparators (LPC)

The PSoC 4000S has a pair of low-power comparators, which can also operate in Deep Sleep modes. This allows the analog system blocks to be disabled while retaining the ability to monitor external voltage levels during low-power modes. The comparator outputs are normally synchronized to avoid metastability unless operating in an asynchronous power mode where the system wake-up circuit is activated by a comparator switch event. The LPC outputs can be routed to pins.

#### Current DACs

The PSoC 4000S has two IDACs, which can drive any of the pins on the chip. These IDACs have programmable current ranges.

#### Analog Multiplexed Buses

The PSoC 4000S has two concentric independent buses that go around the periphery of the chip. These buses (called amux buses) are connected to firmware-programmable analog switches that allow the chip's internal resources (IDACs, comparator) to connect to any pin on the I/O Ports.

#### Programmable Digital Blocks

The programmable I/O (Smart I/O) block is a fabric of switches and LUTs that allows Boolean functions to be performed in signals being routed to the pins of a GPIO port. The Smart I/O can perform logical operations on input pins to the chip and on signals going out as outputs.

#### **Fixed Function Digital**

#### Timer/Counter/PWM (TCPWM) Block

The TCPWM block consists of a 16-bit counter with user-programmable period length. There is a capture register to record the count value at the time of an event (which may be an I/O event), a period register that is used to either stop or auto-reload the counter when its count is equal to the period register, and compare registers to generate compare value signals that are used as PWM duty cycle outputs. The block also provides true and complementary outputs with programmable offset between them to allow use as dead-band programmable complementary PWM outputs. It also has a Kill input to force outputs to a predetermined state; for example, this is used in motor drive systems when an over-current state is indicated and the PWM driving the FETs needs to be shut off immediately with no time for software intervention. There are five TCPWM blocks in the PSoC 4000S.

#### Serial Communication Block (SCB)

The PSoC 4000S has two serial communication blocks, which can be programmed to have SPI, I2C, or UART functionality.

**I<sup>2</sup>C Mode**: The hardware I<sup>2</sup>C block implements a full multi-master and slave interface (it is capable of multi-master arbitration). This block is capable of operating at speeds of up to 1 Mbps (Fast Mode Plus) and has flexible buffering options to reduce interrupt overhead and latency for the CPU. It also supports EZI2C that creates a mailbox address range in the memory of the PSoC 4000S and effectively reduces I<sup>2</sup>C communication to reading from and writing to an array in memory. In addition, the block supports an 8-deep FIFO for receive and transmit which, by increasing the time given for the CPU to read data, greatly reduces the need for clock stretching caused by the CPU not having read data on time.

The I<sup>2</sup>C peripheral is compatible with the I<sup>2</sup>C Standard-mode and Fast-mode devices as defined in the NXP I<sup>2</sup>C-bus specification and user manual (UM10204). The I<sup>2</sup>C bus I/O is implemented with GPIO in open-drain modes.

The PSoC 4000S is not completely compliant with the I<sup>2</sup>C spec in the following respect:

■ GPIO cells are not overvoltage tolerant and, therefore, cannot be hot-swapped or powered up independently of the rest of the I<sup>2</sup>C system.

**UART Mode**: This is a full-feature UART operating at up to 1 Mbps. It supports automotive single-wire interface (LIN), infrared interface (IrDA), and SmartCard (ISO7816) protocols, all of which are minor variants of the basic UART protocol. In addition, it supports the 9-bit multiprocessor mode that allows addressing of peripherals connected over common RX and TX lines. Common UART functions such as parity error, break detect, and frame error are supported. An 8-deep FIFO allows much greater CPU service latencies to be tolerated.

**SPI Mode**: The SPI mode supports full Motorola SPI, TI SSP (adds a start pulse used to synchronize SPI Codecs), and National Microwire (half-duplex form of SPI). The SPI block can use the FIFO.



#### **GPIO**

The PSoC 4000S has up to 36 GPIOs. The GPIO block implements the following:

- Eight drive modes:
- ☐ Analog input mode (input and output buffers disabled)
- □ Input only
- ☐ Weak pull-up with strong pull-down
- □ Strong pull-up with weak pull-down
- □ Open drain with strong pull-down
- □ Open drain with strong pull-up
- ☐ Strong pull-up with strong pull-down
- □ Weak pull-up with weak pull-down
- Input threshold select (CMOS or LVTTL).
- Individual control of input and output buffer enabling/disabling in addition to the drive strength modes
- Selectable slew rates for dV/dt related noise control to improve FMI

The pins are organized in logical entities called ports, which are 8-bit in width (less for Ports 2 and 3). During power-on and reset, the blocks are forced to the disable state so as not to crowbar any inputs and/or cause excess turn-on current. A multiplexing network known as a high-speed I/O matrix is used to multiplex between various signals that may connect to an I/O pin.

Data output and pin state registers store, respectively, the values to be driven on the pins and the states of the pins themselves.

Every I/O pin can generate an interrupt if so enabled and each I/O port has an interrupt request (IRQ) and interrupt service routine (ISR) vector associated with it (5 for PSoC 4000S).

# **Special Function Peripherals**

#### CapSense

CapSense is supported in the PSoC 4000S through a CapSense Sigma-Delta (CSD) block that can be connected to any pins through an analog multiplex bus via analog switches. CapSense function can thus be provided on any available pin or group of pins in a system under software control. A PSoC Creator

component is provided for the CapSense block to make it easy for the user.

Shield voltage can be driven on another analog multiplex bus to provide water-tolerance capability. Water tolerance is provided by driving the shield electrode in phase with the sense electrode to keep the shield capacitance from attenuating the sensed input. Proximity sensing can also be implemented.

The CapSense block has two IDACs, which can be used for general purposes if CapSense is not being used (both IDACs are available in that case) or if CapSense is used without water tolerance (one IDAC is available).

The CapSense block also provides a 10-bit Slope ADC function, which can be used in conjunction with the CapSense function.

The CapSense block is an advanced, low-noise, programmable block with programmable voltage references and current source ranges for improved sensitivity and flexibility. It can also use an external reference voltage. It has a full-wave CSD mode that alternates sensing to VDDA and Ground to null out power-supply related noise.

#### LCD Segment Drive

The PSoC 4000S has an LCD controller, which can drive up to 8 commons and up to 28 segments. It uses full digital methods to drive the LCD segments requiring no generation of internal LCD voltages. The two methods used are referred to as Digital Correlation and PWM. Digital Correlation pertains to modulating the frequency and drive levels of the common and segment signals to generate the highest RMS voltage across a segment to light it up or to keep the RMS signal to zero. This method is good for STN displays but may result in reduced contrast with TN (cheaper) displays. PWM pertains to driving the panel with PWM signals to effectively use the capacitance of the panel to provide the integration of the modulated pulse-width to generate the desired LCD voltage. This method results in higher power consumption but can result in better results when driving TN displays.



# **Pinouts**

The following table provides the pin list for PSoC 4000S for the 48-pin TQFP, 40-pin QFN, 32-pin QFN, 32-pin QFN, 32-pin TQFP, and 25-ball CSP packages. All port pins support GPIO. Pin 11 is a No-Connect in the 48-TQFP.

Table 1. PSoC 4000S Pin List

48-pin	TQFP	32-pi	n QFN	24-pi	n QFN	25-ba	II CSP	40-pi	n QFN	32-pir	TQFP
Pin	Name	Pin	Name	Pin	Name	Pin	Name	Pin	Name	Pin	Name
28	P0.0	17	P0.0	13	P0.0	D1	P0.0	22	P0.0	17	P0.0
29	P0.1	18	P0.1	14	P0.1	C3	P0.1	23	P0.1	18	P0.1
30	P0.2	19	P0.2					24	P0.2	19	P0.2
31	P0.3	20	P0.3					25	P0.3	20	P0.3
32	P0.4	21	P0.4	15	P0.4	C2	P0.4	26	P0.4	21	P0.4
33	P0.5	22	P0.5	16	P0.5	C1	P0.5	27	P0.5	22	P0.5
34	P0.6	23	P0.6	17	P0.6	B1	P0.6	28	P0.6	23	P0.6
35	P0.7					B2	P0.7	29	P0.7		
36	XRES	24	XRES	18	XRES	В3	XRES	30	XRES	24	XRES
37	VCCD	25	VCCD	19	VCCD	A1	VCCD	31	VCCD	25	VCCD
38	VSSD	26	VSSD	20	VSSD	A2	VSS			26	VSSD
39	VDDD	27	VDD	21	VDD	A3	VDD	32	VDDD	27	VDD
40	VDDA	27	VDD	21	VDD	A3	VDD	33	VDDA	27	VDD
41	VSSA	28	VSSA	22	VSSA	A2	VSS	34	VSSA	28	VSSA
42	P1.0	29	P1.0					35	P1.0	29	P1.0
43	P1.1	30	P1.1					36	P1.1	30	P1.1
44	P1.2	31	P1.2	23	P1.2	A4	P1.2	37	P1.2	31	P1.2
45	P1.3	32	P1.3	24	P1.3	B4	P1.3	38	P1.3	32	P1.3
46	P1.4							39	P1.4		
47	P1.5										
48	P1.6										
1	P1.7	1	P1.7	1	P1.7	A5	P1.7	40	P1.7	1	P1.7
2	P2.0	2	P2.0	2	P2.0	B5	P2.0	1	P2.0	2	P2.0
3	P2.1	3	P2.1	3	P2.1	C5	P2.1	2	P2.1	3	P2.1
4	P2.2	4	P2.2					3	P2.2	4	P2.2
5	P2.3	5	P2.3					4	P2.3	5	P2.3
6	P2.4							5	P2.4		
7	P2.5	6	P2.5					6	P2.5	6	P2.5
8	P2.6	7	P2.6	4	P2.6	D5	P2.6	7	P2.6	7	P2.6
9	P2.7	8	P2.7	5	P2.7	C4	P2.7	8	P2.7	8	P2.7
10	VSSD					A2	VSS	9	VSSD		
12	P3.0	9	P3.0	6	P3.0	E5	P3.0	10	P3.0	9	P3.0
13	P3.1	10	P3.1			D4	P3.1	11	P3.1	10	P3.1
14	P3.2	11	P3.2	7	P3.2	E4	P3.2	12	P3.2	11	P3.2
16	P3.3	12	P3.3	8	P3.3	D3	P3.3	13	P3.3	12	P3.3

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Table 1. PSoC 4000S Pin List (continued)

48-pin	TQFP	32-pir	n QFN	24-piı	n QFN	25-ba	II CSP	40-pin QFN		32-pin	TQFP
Pin	Name	Pin	Name	Pin	Name	Pin	Name	Pin	Name	Pin	Name
17	P3.4							14	P3.4		
18	P3.5							15	P3.5		
19	P3.6							16	P3.6		
20	P3.7							17	P3.7		
21	VDDD										
22	P4.0	13	P4.0	9	P4.0	E3	P4.0	18	P4.0	13	P4.0
23	P4.1	14	P4.1	10	P4.1	D2	P4.1	19	P4.1	14	P4.1
24	P4.2	15	P4.2	11	P4.2	E2	P4.2	20	P4.2	15	P4.2
25	P4.3	16	P4.3	12	P4.3	E1	P4.3	21	P4.3	16	P4.3

Note: Pins 11, 15, 26, and 27 are No connects (NC) on the 48-pin TQFP.

Descriptions of the pin functions are as follows:

**VDDD**: Power supply for the digital section. **VDDA**: Power supply for the analog section.

VSSD, VSSA: Ground pins for the digital and analog sections respectively.

VCCD: Regulated digital supply (1.8 V ±5%)
VDD: Power supply to all sections of the chip
VSS: Ground for all sections of the chip

# **Alternate Pin Functions**

Each port pin can be assigned to one of multiple functions; it can, for instance, be an analog I/O, a digital peripheral function, an LCD pin, or a CapSense pin. The pin assignments are shown in the following table.

Table 2. Pin Assignments

Port/ Pin	Analog	Smart I/O	Alternate Function 1	Alternate Function 2	Alternate Function 3	Deep Sleep 1	Deep Sleep 2
P0.0	lpcomp.in_p[0]				tcpwm.tr_in[0]		scb[0].spi_select1:0
P0.1	lpcomp.in_n[0]				tcpwm.tr_in[1]		scb[0].spi_select2:0
P0.2	lpcomp.in_p[1]						scb[0].spi_select3:0
P0.3	lpcomp.in_n[1]						
P0.4	wco.wco_in			scb[1].uart_rx:0		scb[1].i2c_scl:0	scb[1].spi_mosi:1
P0.5	wco.wco_out			scb[1].uart_tx:0		scb[1].i2c_sda:0	scb[1].spi_miso:1
P0.6			srss.ext_clk	scb[1].uart_cts:0			scb[1].spi_clk:1
P0.7				scb[1].uart_rts:0			scb[1].spi_select0:1
P1.0			tcpwm.line[2]:1	scb[0].uart_rx:1		scb[0].i2c_scl:0	scb[0].spi_mosi:1
P1.1			tcpwm.line_compl[2]:1	scb[0].uart_tx:1		scb[0].i2c_sda:0	scb[0].spi_miso:1
P1.2			tcpwm.line[3]:1	scb[0].uart_cts:1	tcpwm.tr_in[2]		scb[0].spi_clk:1
P1.3			tcpwm.line_compl[3]:1	scb[0].uart_rts:1	tcpwm.tr_in[3]		scb[0].spi_select0:1
P1.4							scb[0].spi_select1:1

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# Table 2. Pin Assignments (continued)

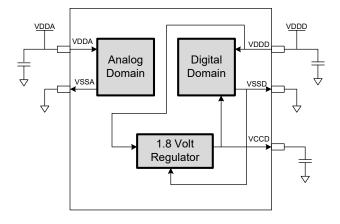
Port/ Pin	Analog	Smart I/O	Alternate Function 1	Alternate Function 2	Alternate Function 3	Deep Sleep 1	Deep Sleep 2
P1.5							scb[0].spi_select2:1
P1.6							scb[0].spi_select3:1
P1.7							
P2.0		prgio[0].io[0]	tcpwm.line[4]:0	csd.comp	tcpwm.tr_in[4]	scb[1].i2c_scl:1	scb[1].spi_mosi:2
P2.1		prgio[0].io[1]	tcpwm.line_compl[4]:0		tcpwm.tr_in[5]	scb[1].i2c_sda:1	scb[1].spi_miso:2
P2.2		prgio[0].io[2]					scb[1].spi_clk:2
P2.3		prgio[0].io[3]					scb[1].spi_select0:2
P2.4		prgio[0].io[4]	tcpwm.line[0]:1				scb[1].spi_select1:1
P2.5		prgio[0].io[5]	tcpwm.line_compl[0]:1				scb[1].spi_select2:1
P2.6		prgio[0].io[6]	tcpwm.line[1]:1				scb[1].spi_select3:1
P2.7		prgio[0].io[7]	tcpwm.line_compl[1]:1			lpcomp.comp[0]:1	
P3.0		prgio[1].io[0]	tcpwm.line[0]:0	scb[1].uart_rx:1		scb[1].i2c_scl:2	scb[1].spi_mosi:0
P3.1		prgio[1].io[1]	tcpwm.line_compl[0]:0	scb[1].uart_tx:1		scb[1].i2c_sda:2	scb[1].spi_miso:0
P3.2		prgio[1].io[2]	tcpwm.line[1]:0	scb[1].uart_cts:1		cpuss.swd_data	scb[1].spi_clk:0
P3.3		prgio[1].io[3]	tcpwm.line_compl[1]:0	scb[1].uart_rts:1		cpuss.swd_clk	scb[1].spi_select0:0
P3.4		prgio[1].io[4]	tcpwm.line[2]:0		tcpwm.tr_in[6]		scb[1].spi_select1:0
P3.5		prgio[1].io[5]	tcpwm.line_compl[2]:0		tcpwm.tr_in[7]		scb[1].spi_select2:0
P3.6		prgio[1].io[6]	tcpwm.line[3]:0		tcpwm.tr_in[8]		scb[1].spi_select3:0
P3.7		prgio[1].io[7]	tcpwm.line_compl[3]:0		tcpwm.tr_in[9]	lpcomp.comp[1]:1	
P4.0	csd.vref_ext			scb[0].uart_rx:0	tcpwm.tr_in[10]	scb[0].i2c_scl:1	scb[0].spi_mosi:0
P4.1	csd.cshieldpads			scb[0].uart_tx:0	tcpwm.tr_in[11]	scb[0].i2c_sda:1	scb[0].spi_miso:0
P4.2	csd.cmodpad			scb[0].uart_cts:0		lpcomp.comp[0]:0	scb[0].spi_clk:0
P4.3	csd.csh_tank			scb[0].uart_rts:0		lpcomp.comp[1]:0	scb[0].spi_select0:0



#### **Power**

The following power system diagram shows the set of power supply pins as implemented for the PSoC 4000S. The system has one regulator in Active mode for the digital circuitry. There is no analog regulator; the analog circuits run directly from the  $\rm V_{\rm DD}$  input.

Figure 4. Power Supply Connections



There are two distinct modes of operation. In Mode 1, the supply voltage range is 1.8 V to 5.5 V (unregulated externally; internal regulator operational). In Mode 2, the supply range is 1.8 V  $\pm$ 5% (externally regulated; 1.71 to 1.89, internal regulator bypassed).

# Mode 1: 1.8 V to 5.5 V External Supply

In this mode, the PSoC 4000S is powered by an external power supply that can be anywhere in the range of 1.8 to 5.5 V. This range is also designed for battery-powered operation. For example, the chip can be powered from a battery system that starts at 3.5 V and works down to 1.8 V. In this mode, the internal regulator of the PSoC 4000S supplies the internal logic and its output is connected to the  $V_{CCD}$  pin. The VCCD pin must be bypassed to ground via an external capacitor (0.1  $\mu F;\ X5R$  ceramic or better) and must not be connected to anything else.

# Mode 2: 1.8 V ±5% External Supply

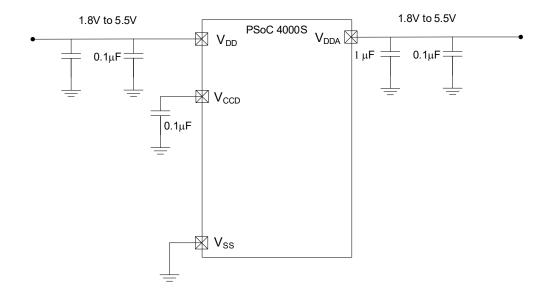
In this mode, the PSoC 4000S is powered by an external power supply that must be within the range of 1.71 to 1.89 V; note that this range needs to include the power supply ripple too. In this mode, the VDD and VCCD pins are shorted together and bypassed. The internal regulator can be disabled in the firmware.

Bypass capacitors must be used from VDDD to ground. The typical practice for systems in this frequency range is to use a capacitor in the 1- $\mu$ F range, in parallel with a smaller capacitor (0.1  $\mu$ F, for example). Note that these are simply rules of thumb and that, for critical applications, the PCB layout, lead inductance, and the bypass capacitor parasitic should be simulated to design and obtain optimal bypassing.

An example of a bypass scheme is shown in the following diagram.

Figure 5. External Supply Range from 1.8 V to 5.5 V with Internal Regulator Active

Power supply bypass connections example





# **Development Support**

The PSoC 4000S has a rich set of documentation, development tools, and online resources to assist you during your development process. Visit www.cypress.com/go/psoc4 to find out more.

#### **Documentation**

A suite of documentation supports the PSoC 4000S to ensure that you can find answers to your questions quickly. This section contains a list of some of the key documents.

**Software User Guide**: A step-by-step guide for using PSoC Creator. The software user guide shows you how the PSoC Creator build process works in detail, how to use source control with PSoC Creator, and much more.

**Component Datasheets**: The flexibility of PSoC allows the creation of new peripherals (components) long after the device has gone into production. Component data sheets provide all of the information needed to select and use a particular component, including a functional description, API documentation, example code, and AC/DC specifications.

**Application Notes**: PSoC application notes discuss a particular application of PSoC in depth; examples include brushless DC

motor control and on-chip filtering. Application notes often include example projects in addition to the application note document.

**Technical Reference Manual**: The Technical Reference Manual (TRM) contains all the technical detail you need to use a PSoC device, including a complete description of all PSoC registers. The TRM is available in the Documentation section at www.cypress.com/psoc4.

#### Online

In addition to print documentation, the Cypress PSoC forums connect you with fellow PSoC users and experts in PSoC from around the world, 24 hours a day, 7 days a week.

#### Tools

With industry standard cores, programming, and debugging interfaces, the PSoC 4000S is part of a development tool ecosystem. Visit us at <a href="https://www.cypress.com/go/psoccreator">www.cypress.com/go/psoccreator</a> for the latest information on the revolutionary, easy to use PSoC Creator IDE, supported third party compilers, programmers, debuggers, and development kits.



# **Electrical Specifications**

# **Absolute Maximum Ratings**

Table 3. Absolute Maximum Ratings<sup>[1]</sup>

		<del>-</del>					
Spec ID#	Parameter	Description	Min	Тур	Max	Units	Details/ Conditions
SID1	V <sub>DDD_ABS</sub>	Digital supply relative to V <sub>SS</sub>	-0.5	_	6	V	_
SID2	V <sub>CCD_ABS</sub>	Direct digital core voltage input relative to V <sub>SS</sub>	-0.5	-	1.95		_
SID3	V <sub>GPIO_ABS</sub>	GPIO voltage	-0.5	_	V <sub>DD</sub> + 0.5		_
SID4	I <sub>GPIO_ABS</sub>	Maximum current per GPIO	-25	_	25	mA	-
SID5	I <sub>GPIO_injection</sub>	GPIO injection current, Max for $V_{IH} > V_{DDD}$ , and Min for $V_{IL} < V_{SS}$	-0.5	-	0.5		Current injected per pin
BID44	ESD_HBM	Electrostatic discharge human body model	2200	_	_	V	-
BID45	ESD_CDM	Electrostatic discharge charged device model	500	_	-		_
BID46	LU	Pin current for latch-up	-140	_	140	mA	_

# Note

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Usage above the absolute maximum conditions listed in Table 3 may cause permanent damage to the device. Exposure to Absolute Maximum conditions for extended
periods of time may affect device reliability. The Maximum Storage Temperature is 150 °C in compliance with JEDEC Standard JESD22-A103, High Temperature
Storage Life. When used below Absolute Maximum conditions but above normal operating conditions, the device may not operate to specification.



# **Device Level Specifications**

All specifications are valid for  $-40~^{\circ}\text{C} \le T_A \le 85~^{\circ}\text{C}$  and  $T_J \le 100~^{\circ}\text{C}$ , except where noted. Specifications are valid for 1.71 V to 5.5 V, except where noted.

# Table 4. DC Specifications

Typical values measured at  $V_{DD}$  = 3.3 V and 25 °C.

Spec ID#	Parameter	Description	Min	Тур	Max	Units	Details/Conditions
SID53	$V_{DD}$	Power supply input voltage	1.8	-	5.5	V	Internally regulated supply
SID255	$V_{DD}$	Power supply input voltage (V <sub>CCD</sub> = V <sub>DD</sub> = V <sub>DDA</sub> )	1.71	_	1.89		Internally unregulated supply
SID54	V <sub>CCD</sub>	Output voltage (for core logic)	-	1.8	_		_
SID55	C <sub>EFC</sub>	External regulator voltage bypass	_	0.1	_	μF	X5R ceramic or better
SID56	C <sub>EXC</sub>	Power supply bypass capacitor	_	1	_		X5R ceramic or better
Active Mode	e, V <sub>DD</sub> = 1.8 V	to 5.5 V. Typical values measure	d at VDD =	3.3 V and 25	5 ℃.		
SID10	I <sub>DD5</sub>	Execute from flash; CPU at 6 MHz	_	1.2	2.0	mA	_
SID16	I <sub>DD8</sub>	Execute from flash; CPU at 24 MHz	_	2.4	4.0		_
SID19	I <sub>DD11</sub>	Execute from flash; CPU at 48 MHz	-	4.6	5.9		_
Sleep Mode	, VDDD = 1.8 '	V to 5.5 V (Regulator on)					
SID22	I <sub>DD17</sub>	I <sup>2</sup> C wakeup WDT, and Comparators on	-	1.1	1.6	mA	6 MHz
SID25	I <sub>DD20</sub>	I <sup>2</sup> C wakeup, WDT, and Comparators on	-	1.4	1.9		12 MHz
Sleep Mode	, V <sub>DDD</sub> = 1.71	V to 1.89 V (Regulator bypassed	)		•	· · ·	
SID28	I <sub>DD23</sub>	I <sup>2</sup> C wakeup, WDT, and Comparators on	-	0.7	0.9	mA	6 MHz
SID28A	I <sub>DD23A</sub>	I <sup>2</sup> C wakeup, WDT, and Comparators on	-	0.9	1.1	mA	12 MHz
Deep Sleep	Mode, V <sub>DD</sub> =	1.8 V to 3.6 V (Regulator on)					
SID31	I <sub>DD26</sub>	I <sup>2</sup> C wakeup and WDT on	-	2.5	60	μΑ	_
Deep Sleep	Mode, V <sub>DD</sub> =	3.6 V to 5.5 V (Regulator on)					
SID34	I <sub>DD29</sub>	I <sup>2</sup> C wakeup and WDT on	_	2.5	60	μA	_
Deep Sleep	Mode, V <sub>DD</sub> =	V <sub>CCD</sub> = 1.71 V to 1.89 V (Regulate	or bypassed	i)		1	1
SID37	I <sub>DD32</sub>	I <sup>2</sup> C wakeup and WDT on	-	2.5	60	μA	_
XRES Curre	nt					1	
SID307	I <sub>DD_XR</sub>	Supply current while XRES asserted	-	2	5	mA	_

# Table 5. AC Specifications

Spec ID#	Parameter	Description	Min	Тур	Max	Units	Details/Conditions
SID48	F <sub>CPU</sub>	CPU frequency	DC	-	48	MHz	$1.71 \le V_{DD} \le 5.5$
SID49 <sup>[2]</sup>	T <sub>SLEEP</sub>	Wakeup from Sleep mode	_	0	_	μs	
SID50 <sup>[2]</sup>	T <sub>DEEPSLEEP</sub>	Wakeup from Deep Sleep mode	-	35	_		

# Note

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<sup>2.</sup> Guaranteed by characterization.



GPIO

# Table 6. GPIO DC Specifications

Spec ID#	Parameter	Description	Min	Тур	Max	Units	Details/Conditions
SID57	V <sub>IH</sub> <sup>[3]</sup>	Input voltage high threshold	$0.7 \times V_{DDD}$	_	_	V	CMOS Input
SID58	V <sub>IL</sub>	Input voltage low threshold	_	_	$0.3 \times V_{DDD}$		CMOS Input
SID241	V <sub>IH</sub> <sup>[3]</sup>	LVTTL input, V <sub>DDD</sub> < 2.7 V	$0.7 \times V_{DDD}$	_	_		-
SID242	V <sub>IL</sub>	LVTTL input, V <sub>DDD</sub> < 2.7 V	_	_	$0.3 \times V_{DDD}$		-
SID243	V <sub>IH</sub> <sup>[3]</sup>	LVTTL input, V <sub>DDD</sub> ≥ 2.7 V	2.0	_	_		_
SID244	V <sub>IL</sub>	LVTTL input, V <sub>DDD</sub> ≥ 2.7 V	_	_	0.8		-
SID59	V <sub>OH</sub>	Output voltage high level	V <sub>DDD</sub> – 0.6	_	_		I <sub>OH</sub> = 4 mA at 3 V V <sub>DDD</sub>
SID60	V <sub>OH</sub>	Output voltage high level	V <sub>DDD</sub> – 0.5	_	-		I <sub>OH</sub> = 1 mA at 3 V V <sub>DDD</sub>
SID61	V <sub>OL</sub>	Output voltage low level	_	_	0.6		I <sub>OL</sub> = 4 mA at 1.8 V V <sub>DDD</sub>
SID62	V <sub>OL</sub>	Output voltage low level	-	_	0.6		I <sub>OL</sub> = 10 mA at 3 V V <sub>DDD</sub>
SID62A	V <sub>OL</sub>	Output voltage low level	-	-	0.4		I <sub>OL</sub> = 3 mA at 3 V V <sub>DDD</sub>
SID63	R <sub>PULLUP</sub>	Pull-up resistor	3.5	5.6	8.5	kΩ	_
SID64	R <sub>PULLDOWN</sub>	Pull-down resistor	3.5	5.6	8.5		_
SID65	I <sub>IL</sub>	Input leakage current (absolute value)	-	_	2	nA	25 °C, V <sub>DDD</sub> = 3.0 V
SID66	C <sub>IN</sub>	Input capacitance	_	_	7	pF	_
SID67 <sup>[4]</sup>	V <sub>HYSTTL</sub>	Input hysteresis LVTTL	25	40	_	mV	$V_{DDD} \ge 2.7 \text{ V}$
SID68 <sup>[4]</sup>	V <sub>HYSCMOS</sub>	Input hysteresis CMOS	0.05 × V <sub>DDD</sub>	_	_		V <sub>DD</sub> < 4.5 V
SID68A <sup>[4]</sup>	V <sub>HYSCMOS5V5</sub>	Input hysteresis CMOS	200	_	_		V <sub>DD</sub> > 4.5 V
SID69 <sup>[4]</sup>	I <sub>DIODE</sub>	Current through protection diode to V <sub>DD</sub> /V <sub>SS</sub>	-	_	100	μA	-
SID69A <sup>[4]</sup>	I <sub>TOT_GPIO</sub>	Maximum total source or sink chip current	-	_	200	mA	_

V<sub>IH</sub> must not exceed V<sub>DDD</sub> + 0.2 V.
 Guaranteed by characterization.



Table 7. GPIO AC Specifications

(Guaranteed by Characterization)

Spec ID#	Parameter	Description	Min	Тур	Max	Units	Details/Conditions
SID70	T <sub>RISEF</sub>	Rise time in fast strong mode	2	-	12	ns	3.3 V V <sub>DDD</sub> , Cload = 25 pF
SID71	T <sub>FALLF</sub>	Fall time in fast strong mode	2	_	12		3.3 V V <sub>DDD</sub> , Cload = 25 pF
SID72	T <sub>RISES</sub>	Rise time in slow strong mode	10	_	60	_	3.3 V V <sub>DDD</sub> , Cload = 25 pF
SID73	T <sub>FALLS</sub>	Fall time in slow strong mode	10	_	60	_	3.3 V V <sub>DDD</sub> , Cload = 25 pF
SID74	F <sub>GPIOUT1</sub>	GPIO F <sub>OUT</sub> ; 3.3 V ≤ V <sub>DDD</sub> ≤ 5.5 V Fast strong mode	_	_	33	MHz	90/10%, 25 pF load, 60/40 duty cycle
SID75	F <sub>GPIOUT2</sub>	GPIO F <sub>OUT</sub> ; 1.71 V≤V <sub>DDD</sub> ≤3.3 V Fast strong mode	_	_	16.7		90/10%, 25 pF load, 60/40 duty cycle
SID76	F <sub>GPIOUT3</sub>	GPIO $F_{OUT}$ ; 3.3 $V \le V_{DDD} \le 5.5 V$ Slow strong mode	_	_	7		90/10%, 25 pF load, 60/40 duty cycle
SID245	F <sub>GPIOUT4</sub>	GPIO $F_{OUT}$ ; 1.71 $V \le V_{DDD} \le$ 3.3 $V$ Slow strong mode.	-	_	3.5		90/10%, 25 pF load, 60/40 duty cycle
SID246	F <sub>GPIOIN</sub>	GPIO input operating frequency; 1.71 V ≤ V <sub>DDD</sub> ≤ 5.5 V	_	_	48		90/10% V <sub>IO</sub>

#### XRES

# Table 8. XRES DC Specifications

Spec ID#	Parameter	Description	Min	Тур	Max	Units	Details/Conditions
SID77	V <sub>IH</sub>	Input voltage high threshold	$0.7 \times V_{DDD}$	_	-	V	CMOS Input
SID78	$V_{IL}$	Input voltage low threshold	_	_	$0.3 \times V_{DDD}$		
SID79	R <sub>PULLUP</sub>	Pull-up resistor	_	60	-	kΩ	-
SID80	C <sub>IN</sub>	Input capacitance	_	_	7	pF	-
SID81 <sup>[5]</sup>	V <sub>HYSXRES</sub>	Input voltage hysteresis	_	100	-	mV	Typical hysteresis is 200 mV for V <sub>DD</sub> > 4.5 V
SID82	I <sub>DIODE</sub>	Current through protection diode to V <sub>DD</sub> /V <sub>SS</sub>	_	-	100	μA	_

# Table 9. XRES AC Specifications

Spec ID#	Parameter	Description	Min	Тур	Max	Units	Details/Conditions
SID83 <sup>[5]</sup>	T <sub>RESETWIDTH</sub>	Reset pulse width	1	_	-	μs	_
BID194 <sup>[5]</sup>	T <sub>RESETWAKE</sub>	Wake-up time from reset release	_	_	2.7	ms	_

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Note
5. Guaranteed by characterization.



# **Analog Peripherals**

Comparator

**Table 10. Comparator DC Specifications** 

Spec ID#	Parameter	Description	Min	Тур	Max	Units	Details/Conditions
SID84	V <sub>OFFSET1</sub>	Input offset voltage, Factory trim	-	-	±10	mV	-
SID85	V <sub>OFFSET2</sub>	Input offset voltage, Custom trim	_	_	±4		_
SID86	V <sub>HYST</sub>	Hysteresis when enabled	_	10	35		_
SID87	V <sub>ICM1</sub>	Input common mode voltage in normal mode	0	_	V <sub>DDD</sub> – 0.1	V	Modes 1 and 2
SID247	V <sub>ICM2</sub>	Input common mode voltage in low power mode	0	_	V <sub>DDD</sub>		-
SID247A	V <sub>ICM3</sub>	Input common mode voltage in ultra low power mode	0	_	V <sub>DDD</sub> – 1.15		V <sub>DDD</sub> ≥ 2.2 V at –40 °C
SID88	C <sub>MRR</sub>	Common mode rejection ratio	50	_	_	dB	V <sub>DDD</sub> ≥ 2.7V
SID88A	C <sub>MRR</sub>	Common mode rejection ratio	42	_	-		V <sub>DDD</sub> ≤ 2.7V
SID89	I <sub>CMP1</sub>	Block current, normal mode	_	_	400	μA	_
SID248	I <sub>CMP2</sub>	Block current, low power mode	_	_	100		_
SID259	I <sub>CMP3</sub>	Block current in ultra low-power mode	_	6	28		V <sub>DDD</sub> ≥ 2.2 V at –40 °C
SID90	Z <sub>CMP</sub>	DC Input impedance of comparator	35	_	_	ΜΩ	-

**Table 11. Comparator AC Specifications** 

Spec ID#	Parameter	Description	Min	Тур	Max	Units	Details/Conditions
SID91	TRESP1	Response time, normal mode, 50 mV overdrive	-	38	110	ns	_
SID258	TRESP2	Response time, low power mode, 50 mV overdrive	-	70	200		-
SID92	TRESP3	Response time, ultra-low power mode, 200 mV overdrive	-	2.3	15	μs	V <sub>DDD</sub> ≥ 2.2 V at –40 °C

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# CSD and IDAC

Table 12. CSD and IDAC Specifications

SPEC ID#	Parameter	Description	Min	Тур	Max	Units	Details/Conditions
SYS.PER#3	VDD_RIPPLE	Max allowed ripple on power supply, DC to 10 MHz	_	_	±50	mV	V <sub>DD</sub> > 2 V (with ripple), 25 °C T <sub>A</sub> , Sensitivity = 0.1 pF
SYS.PER#16	VDD_RIPPLE_1.8	Max allowed ripple on power supply, DC to 10 MHz	-	-	±25	mV	$V_{DD}$ > 1.75V (with ripple), 25 °C T <sub>A</sub> , Parasitic Capacitance (C <sub>P</sub> ) < 20 pF, Sensitivity $\geq$ 0.4 pF
SID.CSD.BLK	ICSD	Maximum block current	-	-	4000	μΑ	Maximum block current for both IDACs in dynamic (switching) mode including comparators, buffer, and reference generator.
SID.CSD#15	V <sub>REF</sub>	Voltage reference for CSD and Comparator	0.6	1.2	V <sub>DDA</sub> - 0.6	V	V <sub>DDA</sub> – 0.6 or 4.4, whichever is lower
SID.CSD#15A	V <sub>REF_EXT</sub>	External Voltage reference for CSD and Comparator	0.6	-	V <sub>DDA</sub> - 0.6	<b>V</b>	V <sub>DDA</sub> – 0.6 or 4.4, whichever is lower
SID.CSD#16	IDAC1IDD	IDAC1 (7-bits) block current	-	_	1750	μΑ	
SID.CSD#17	IDAC2IDD	IDAC2 (7-bits) block current	-	-	1750	μΑ	
SID308	VCSD	Voltage range of operation	1.71	-	5.5	<b>V</b>	1.8 V ±5% or 1.8 V to 5.5 V
SID308A	V <sub>COMPIDAC</sub>	Voltage compliance range of IDAC	0.6	_	V <sub>DDA</sub> – 0.6	V	V <sub>DDA</sub> – 0.6 or 4.4, whichever is lower
SID309	IDAC1DNL	DNL	<b>–</b> 1	_	1	LSB	
SID310	IDAC1INL	INL	-2	_	2	LSB	INL is ±5.5 LSB for V <sub>DDA</sub> < 2 V
SID311	IDAC2DNL	DNL	<b>–</b> 1	-	1	LSB	
SID312	IDAC2INL	INL	-2	-	2	LSB	INL is ±5.5 LSB for V <sub>DDA</sub> < 2 V
SID313	SNR	Ratio of counts of finger to noise. Guaranteed by characterization	5	_	_	Ratio	Capacitance range of 5 to 35 pF, 0.1-pF sensitivity. All use cases. V <sub>DDA</sub> > 2 V.
SID314	IDAC1CRT1	Output current of IDAC1 (7 bits) in low range	4.2	-	5.4	μA	LSB = 37.5-nA typ.
SID314A	IDAC1CRT2	Output current of IDAC1(7 bits) in medium range	34	-	41	μΑ	LSB = 300-nA typ.
SID314B	IDAC1CRT3	Output current of IDAC1(7 bits) in high range	275	-	330	μΑ	LSB = 2.4-µA typ.
SID314C	IDAC1CRT12	Output current of IDAC1 (7 bits) in low range, 2X mode	8	-	10.5	μΑ	LSB = 75-nA typ.
SID314D	IDAC1CRT22	Output current of IDAC1(7 bits) in medium range, 2X mode	69	-	82	μΑ	LSB = 600-nA typ.
SID314E	IDAC1CRT32	Output current of IDAC1(7 bits) in high range, 2X mode	540	-	660	μΑ	LSB = 4.8-µA typ.
SID315	IDAC2CRT1	Output current of IDAC2 (7 bits) in low range	4.2	-	5.4	μΑ	LSB = 37.5-nA typ.

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Table 12. CSD and IDAC Specifications (continued)

SPEC ID#	Parameter	Description	Min	Тур	Max	Units	Details/Conditions
SID315A	IDAC2CRT2	Output current of IDAC2 (7 bits) in medium range	34	_	41	μA	LSB = 300-nA typ.
SID315B	IDAC2CRT3	Output current of IDAC2 (7 bits) in high range	275	_	330	μA	LSB = 2.4-µA typ.
SID315C	IDAC2CRT12	Output current of IDAC2 (7 bits) in low range, 2X mode	8	-	10.5	μA	LSB = 75-nA typ.
SID315D	IDAC2CRT22	Output current of IDAC2(7 bits) in medium range, 2X mode	69	_	82	μA	LSB = 600-nA typ.
SID315E	IDAC2CRT32	Output current of IDAC2(7 bits) in high range, 2X mode	540	-	660	μA	LSB = 4.8-µA typ.
SID315F	IDAC3CRT13	Output current of IDAC in 8-bit mode in low range	8	-	10.5	μA	LSB = 37.5-nA typ.
SID315G	IDAC3CRT23	Output current of IDAC in 8-bit mode in medium range	69	_	82	μA	LSB = 300-nA typ.
SID315H	IDAC3CRT33	Output current of IDAC in 8-bit mode in high range	540	-	660	μA	LSB = 2.4-µA typ.
SID320	IDACOFFSET	All zeroes input	-	-	1	LSB	Polarity set by Source or Sink. Offset is 2 LSBs for 37.5 nA/LSB mode
SID321	IDACGAIN	Full-scale error less offset	_	_	±10	%	
SID322	IDACMISMATCH1	Mismatch between IDAC1 and IDAC2 in Low mode	_	_	9.2	LSB	LSB = 37.5-nA typ.
SID322A	IDACMISMATCH2	Mismatch between IDAC1 and IDAC2 in Medium mode	_	-	5.6	LSB	LSB = 300-nA typ.
SID322B	IDACMISMATCH3	Mismatch between IDAC1 and IDAC2 in High mode	-	_	6.8	LSB	LSB = 2.4-µA typ.
SID323	IDACSET8	Settling time to 0.5 LSB for 8-bit IDAC	-	_	10	μs	Full-scale transition. No external load.
SID324	IDACSET7	Settling time to 0.5 LSB for 7-bit IDAC	_	-	10	μs	Full-scale transition. No external load.
SID325	CMOD	External modulator capacitor.	_	2.2	_	nF	5-V rating, X7R or NP0 cap.



# 10-bit CapSense ADC

Table 13. 10-bit CapSense ADC Specifications

Spec ID#	Parameter	Description	Min	Тур	Max	Units	Details/Conditions
SIDA94	A_RES	Resolution	-	_	10	bits	Auto-zeroing is required every millisecond
SIDA95	A_CHNLS_S	Number of channels - single ended	_	_	16		Defined by AMUX Bus.
SIDA97	A-MONO	Monotonicity	_	_	_	Yes	
SIDA98	A_GAINERR	Gain error	-	_	±2	%	In V <sub>REF</sub> (2.4 V) mode with V <sub>DDA</sub> bypass capacitance of 10 μF
SIDA99	A_OFFSET	Input offset voltage	-	_	3	mV	In $V_{REF}$ (2.4 V) mode with $V_{DDA}$ bypass capacitance of 10 $\mu F$
SIDA100	A_ISAR	Current consumption	_	_	0.25	mA	
SIDA101	A_VINS	Input voltage range - single ended	$V_{SSA}$	_	V <sub>DDA</sub>	V	
SIDA103	A_INRES	Input resistance	_	2.2	_	ΚΩ	
SIDA104	A_INCAP	Input capacitance	_	20	_	pF	
SIDA106	A_PSRR	Power supply rejection ratio	-	60	-	dB	In V <sub>REF</sub> (2.4 V) mode with V <sub>DDA</sub> bypass capacitance of 10 μF
SIDA107	A_TACQ	Sample acquisition time	_	1	_	μs	
SIDA108	A_CONV8	Conversion time for 8-bit resolution at conversion rate = Fhclk/(2^(N+2)). Clock frequency = 48 MHz.	-	-	21.3	μs	Does not include acquisition time. Equivalent to 44.8 ksps including acquisition time.
SIDA108A	A_CONV10	Conversion time for 10-bit resolution at conversion rate = Fhclk/(2^(N+2)). Clock frequency = 48 MHz.	-	-	85.3	μs	Does not include acquisition time. Equivalent to 11.6 ksps including acquisition time.
SIDA109	A_SND	Signal-to-noise and Distortion ratio (SINAD)	-	61	_	dB	With 10-Hz input sine wave, external 2.4-V reference, V <sub>REF</sub> (2.4 V) mode
SIDA110	A_BW	Input bandwidth without aliasing	_	_	22.4	kHz	8-bit resolution
SIDA111	A_INL	Integral Non Linearity. 1 ksps	-	_	2	LSB	V <sub>REF</sub> = 2.4 V or greater
SIDA112	A_DNL	Differential Non Linearity. 1 ksps	_	_	1	LSB	



# **Digital Peripherals**

Timer Counter Pulse-Width Modulator (TCPWM)

**Table 14. TCPWM Specifications** 

Spec ID	Parameter	Description	Min	Тур	Max	Units	Details/Conditions
SID.TCPWM.1	ITCPWM1	Block current consumption at 3 MHz	_	_	45	μA	All modes (TCPWM)
SID.TCPWM.2	ITCPWM2	Block current consumption at 12 MHz	_	_	155		All modes (TCPWM)
SID.TCPWM.2A	ITCPWM3	Block current consumption at 48 MHz	_	_	650		All modes (TCPWM)
SID.TCPWM.3	TCPWM <sub>FREQ</sub>	Operating frequency	-	_	Fc	MHz	Fc max = CLK_SYS Maximum = 48 MHz
SID.TCPWM.4	TPWM <sub>ENEXT</sub>	Input trigger pulse width	2/Fc	_	_	ns	For all trigger events <sup>[6]</sup>
SID.TCPWM.5	TPWM <sub>EXT</sub>	Output trigger pulse widths	2/Fc	-	-		Minimum possible width of Overflow, Underflow, and CC (Counter equals Compare value) outputs
SID.TCPWM.5A	TC <sub>RES</sub>	Resolution of counter	1/Fc	_	_		Minimum time between successive counts
SID.TCPWM.5B	PWM <sub>RES</sub>	PWM resolution	1/Fc	_	_		Minimum pulse width of PWM Output
SID.TCPWM.5C	Q <sub>RES</sub>	Quadrature inputs resolution	1/Fc	_	_		Minimum pulse width between Quadrature phase inputs

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Note
6. Trigger events can be Stop, Start, Reload, Count, Capture, or Kill depending on which mode of operation is selected.



 $I^2C$ 

# Table 15. Fixed I<sup>2</sup>C DC Specifications<sup>[7]</sup>

Spec ID	Parameter	Description	Min	Тур	Max	Units	Details/Conditions
SID149	I <sub>I2C1</sub>	Block current consumption at 100 kHz	_	_	50	μA	-
SID150	I <sub>I2C2</sub>	Block current consumption at 400 kHz	-	_	135		_
SID151	I <sub>I2C3</sub>	Block current consumption at 1 Mbps	-	-	310		-
SID152	I <sub>I2C4</sub>	I <sup>2</sup> C enabled in Deep Sleep mode	-	ı	1.4	•	-

# Table 16. Fixed I<sup>2</sup>C AC Specifications<sup>[7]</sup>

Spec ID	Parameter	Description	Min	Тур	Max	Units	Details/Conditions
SID153	F <sub>I2C1</sub>	Bit rate	_	-	1	Msps	-

SPI

# Table 17. SPI DC Specifications<sup>[7]</sup>

Spec ID	Parameter	Description	Min	Тур	Max	Units	Details/Conditions
SID163	ISPI1	Block current consumption at 1 Mbps	-	_	360	μA	-
SID164	ISPI2	Block current consumption at 4 Mbps	_	_	560		-
SID165	ISPI3	Block current consumption at 8 Mbps	_	_	600		-

# Table 18. SPI AC Specifications<sup>[7]</sup>

Spec ID	Parameter	Description	Min	Тур	Max	Units	Details/Conditions
SID166	FSPI	SPI operating frequency (Master; 6X Oversampling)	-	_	8	MHz	-
Fixed SPI M	aster Mode AC	Specifications				•	
SID167	TDMO	MOSI Valid after SClock driving edge	-	_	15	ns	-
SID168	TDSI	MISO Valid before SClock capturing edge	20	_	-		Full clock, late MISO sampling
SID169	THMO	Previous MOSI data hold time	0	_	-		Referred to Slave capturing edge
Fixed SPI S	lave Mode AC S	pecifications					
SID170	TDMI	MOSI Valid before Sclock Capturing edge	40	_	-	ns	-
SID171	TDSO	MISO Valid after Sclock driving edge	-	_	42 + (3 × Tcpu)		T <sub>CPU</sub> = 1/F <sub>CPU</sub>
SID171A	TDSO_EXT	MISO Valid after Sclock driving edge in Ext. Clk mode	-	_	48		_
SID172	THSO	Previous MISO data hold time	0	_	_		_
SID172A	TSSELSSCK	SSEL Valid to first SCK Valid edge	100	_	-	ns	-

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Note
7. Guaranteed by characterization.



#### **UART**

# Table 19. UART DC Specifications<sup>[8]</sup>

Spec ID	Parameter	Description	Min	Тур	Max	Units	Details/Conditions
SID160	I <sub>UART1</sub>	Block current consumption at 100 Kbps	_	ı	55	μA	_
SID161	I <sub>UART2</sub>	Block current consumption at 1000 Kbps	-	-	312	μA	-

# Table 20. UART AC Specifications $^{[8]}$

Spec ID	Parameter	Description	Min	Тур	Max	Units	Details/Conditions
SID162	F <sub>UART</sub>	Bit rate	_	_	1	Mbps	_

# LCD Direct Drive

# Table 21. LCD Direct Drive DC Specifications<sup>[8]</sup>

Spec ID	Parameter	Description	Min	Тур	Max	Units	Details/Conditions
SID154	I <sub>LCDLOW</sub>	Operating current in low power mode	-	5	-	μA	16 × 4 small segment disp. at 50 Hz
SID155	C <sub>LCDCAP</sub>	LCD capacitance per segment/common driver	-	500	5000	pF	_
SID156	LCD <sub>OFFSET</sub>	Long-term segment offset	-	20	-	mV	_
SID157	I <sub>LCDOP1</sub>	LCD system operating current Vbias = 5 V	-	2	-	mA	$32 \times 4$ segments. 50 Hz. 25 °C
SID158	I <sub>LCDOP2</sub>	LCD system operating current Vbias = 3.3 V	-	2	_		32 × 4 segments. 50 Hz. 25 °C

# Table 22. LCD Direct Drive AC Specifications<sup>[8]</sup>

Spec ID	Parameter	Description	Min	Тур	Max	Units	Details/Conditions
SID159	F <sub>LCD</sub>	LCD frame rate	10	50	150	Hz	_

**Note**8. Guaranteed by characterization.



# Memory

Flash

#### Table 23. Flash DC Specifications

Spec ID	Parameter	Description	Min	Тур	Max	Units	Details/Conditions
SID173	$V_{PE}$	Erase and program voltage	1.71	1	5.5	٧	-

# Table 24. Flash AC Specifications

Spec ID	Parameter	Description	Min	Тур	Max	Units	Details/Conditions
SID174	T <sub>ROWWRITE</sub> <sup>[9]</sup>	Row (block) write time (erase and program)	_	_	20	ms	Row (block) = 128 bytes
SID175	T <sub>ROWERASE</sub> <sup>[9]</sup>	Row erase time	-	_	16		_
SID176	T <sub>ROWPROGRAM</sub> <sup>[9]</sup>	Row program time after erase	_	_	4		_
SID178	T <sub>BULKERASE</sub> <sup>[9]</sup>	Bulk erase time (32 KB)	_	_	35		_
SID180 <sup>[10]</sup>	T <sub>DEVPROG</sub> <sup>[9]</sup>	Total device program time	_	_	7	Seconds	-
SID181 <sup>[10]</sup>	F <sub>END</sub>	Flash endurance	100 K	_	_	Cycles	-
	F <sub>RET</sub>	Flash retention. T <sub>A</sub> ≤ 55 °C, 100 K P/E cycles	20	_	_	Years	-
SID182A <sup>[10]</sup>	_	Flash retention. T <sub>A</sub> ≤ 85 °C, 10 K P/E cycles	10	_	_		-
SID256	TWS48	Number of Wait states at 48 MHz	2	_	_		CPU execution from Flash
SID257	TWS24	Number of Wait states at 24 MHz	1	_	_		CPU execution from Flash

# **System Resources**

Power-on Reset (POR)

# Table 25. Power On Reset (PRES)

Spec ID	Parameter	Description	Min	Тур	Max	Units	Details/Conditions
SID.CLK#6	SR_POWER_UP	Power supply slew rate	1	1	67	V/ms	At power-up
SID185 <sup>[10]</sup>	V <sub>RISEIPOR</sub>	Rising trip voltage	0.80	1	1.5	V	-
SID186 <sup>[10]</sup>	V <sub>FALLIPOR</sub>	Falling trip voltage	0.70	-	1.4		-

# Table 26. Brown-out Detect (BOD) for V<sub>CCD</sub>

Spec ID	Parameter	Description	Min	Тур	Max	Units	Details/Conditions
SID190 <sup>[10]</sup>	V <sub>FALLPPOR</sub>	BOD trip voltage in active and sleep modes	1.48	_	1.62	V	-
SID192 <sup>[10]</sup>	V <sub>FALLDPSLP</sub>	BOD trip voltage in Deep Sleep	1.11	_	1.5		_

#### Notes

It can take as much as 20 milliseconds to write to Flash. During this time the device should not be Reset, or Flash operations will be interrupted and cannot be relied
on to have completed. Reset sources include the XRES pin, software resets, CPU lockup states and privilege violations, improper power supply levels, and watchdogs.
Make certain that these are not inadvertently activated.

<sup>10.</sup> Guaranteed by characterization.



# SWD Interface

# **Table 27. SWD Interface Specifications**

Spec ID	Parameter	Description	Min	Тур	Max	Units	Details/Conditions
SID213	F_SWDCLK1	$3.3~V \leq V_{DD} \leq 5.5~V$	_	_	14		SWDCLK ≤ 1/3 CPU clock frequency
SID214	F_SWDCLK2	$1.71 \text{ V} \le \text{V}_{DD} \le 3.3 \text{ V}$	-	_	7		SWDCLK ≤ 1/3 CPU clock frequency
SID215 <sup>[11]</sup>	T_SWDI_SETUP	T = 1/f SWDCLK	0.25 × T	_	-	ns	_
SID216 <sup>[11]</sup>	T_SWDI_HOLD	T = 1/f SWDCLK	0.25 × T	_	-		_
SID217 <sup>[11]</sup>	T_SWDO_VALID	T = 1/f SWDCLK	_	_	0.5 × T		_
SID217A <sup>[11]</sup>	T_SWDO_HOLD	T = 1/f SWDCLK	1	-	-		_

Internal Main Oscillator (IMO)

# Table 28. IMO DC Specifications

(Guaranteed by Design)

Spec ID	Parameter	Description	Min	Тур	Max	Units	Details/Conditions
SID218	I <sub>IMO1</sub>	IMO operating current at 48 MHz	-	_	250	μA	_
SID219	I <sub>IMO2</sub>	IMO operating current at 24 MHz	-	_	180	μA	_

# Table 29. IMO AC Specifications

Spec ID	Parameter	Description	Min	Тур	Max	Units	Details/Conditions
SID223		Frequency variation at 24, 32, and 48 MHz (trimmed)	-	-	±2	%	-
SID226	T <sub>STARTIMO</sub>	IMO startup time	-	1	7	μs	_
SID228	T <sub>JITRMSIMO2</sub>	RMS jitter at 24 MHz	-	145	_	ps	_

Internal Low-Speed Oscillator (ILO)

# Table 30. ILO DC Specifications

(Guaranteed by Design)

Spec ID	Parameter	Description	Min	Тур	Max	Units	Details/Conditions
SID231 <sup>[11]</sup>	I <sub>ILO1</sub>	ILO operating current	_	0.3	1.05	μA	_

# Table 31. ILO AC Specifications

Spec ID	Parameter	Description	Min	Тур	Max	Units	Details/Conditions
SID234 <sup>[11]</sup>	T <sub>STARTILO1</sub>	ILO startup time	_	1	2	ms	_
SID236 <sup>[11]</sup>	T <sub>ILODUTY</sub>	ILO duty cycle	40	50	60	%	_
SID237	F <sub>ILOTRIM1</sub>	ILO frequency range	20	40	80	kHz	_

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**Note** 11. Guaranteed by characterization.



Watch Crystal Oscillator (WCO)

# Table 32. Watch Crystal Oscillator (WCO) Specifications

Spec ID#	Parameter	Description	Min	Тур	Max	Units	Details/Conditions
SID398	FWCO	Crystal Frequency	_	32.768	_	kHz	
SID399	FTOL	Frequency tolerance	_	50	250	ppm	With 20-ppm crystal
SID400	ESR	Equivalent series resistance	_	50	_	kΩ	
SID401	PD	Drive Level	_	_	1	μW	
SID402	TSTART	Startup time	_	_	500	ms	
SID403	CL	Crystal Load Capacitance	6	_	12.5	pF	
SID404	C0	Crystal Shunt Capacitance	_	1.35	_	pF	
SID405	IWCO1	Operating Current (high power mode)	-	_	8	μΑ	
SID406	IWCO2	Operating Current (low power mode)	-	_	1	μΑ	

#### External Clock

# Table 33. External Clock Specifications

Spec ID	Parameter	Description	Min	Тур	Max	Units	Details/Conditions
	ExtClkFreq	External clock input frequency	0	-	48	MHz	_
SID306 <sup>[12]</sup>	ExtClkDuty	Duty cycle; measured at V <sub>DD/2</sub>	45	-	55	%	_

# Clock

# Table 34. Clock Specs

Spec ID	Parameter	Description	Min	Тур	Max	Units	Details/Conditions
SID262 <sup>[12]</sup>	T <sub>CLKSWITCH</sub>	System clock source switching time	3	-	4	Periods	_

# Smart I/O Pass-through Time

# Table 35. Smart I/O Pass-through Time (Delay in Bypass Mode)

Spec ID#	Parameter	Description	Min	Тур	Max	Units	Details/Conditions
SID252	PRG_BYPASS	Max delay added by Smart I/O in	_	_	1.6	ns	
		bypass mode					

**Note** 12. Guaranteed by characterization.



# **Ordering Information**

The PSoC 4000S part numbers and features are listed in the following table.

Table 36. PSoC 4000S Ordering Information

							Feat	ures								Pac	kage		
Category	MPN	Max CPU Speed (MHz)	Flash (KB)	SRAM (KB)	Opamp (CTBm)	CapSense	10-bit CSD ADC	12-bit SAR ADC	LP Comparators	TCPWM Blocks	SCB Blocks	Smart I/Os	GPIO	WLCSP (0.35-mm pitch)	24-pin QFN	32-pin QFN	32-pin TQFP	40-pin QFN	48-pin TQFP
4024	CY8C4024FNI-S402	24	16	2	0	0	1	0	2	5	2	8	21	~					
	CY8C4024LQI-S401	24	16	2	0	0	1	0	2	5	2	8	19		~				
	CY8C4024LQI-S402	24	16	2	0	0	1	0	2	5	2	16	27			~			
	CY8C4024AXI-S402	24	16	2	0	0	1	0	2	5	2	16	27				~		
	CY8C4024LQI-S403	24	16	2	0	0	1	0	2	5	2	16	34					~	
	CY8C4024AZI-S403	24	16	2	0	0	1	0	2	5	2	16	36						~
	CY8C4024FNI-S412	24	16	2	0	1	1	0	2	5	2	8	21	~					
	CY8C4024LQI-S411	24	16	2	0	1	1	0	2	5	2	8	19		~				
	CY8C4024LQI-S412	24	16	2	0	1	1	0	2	5	2	16	27			~			
	CY8C4024AXI-S412	24	16	2	0	1	1	0	2	5	2	16	27				~		
	CY8C4024LQI-S413	24	16	2	0	1	1	0	2	5	2	16	34					~	
	CY8C4024AZI-S413	24	16	2	0	1	1	0	2	5	2	16	36						~
4025	CY8C4025FNI-S402	24	32	4	0	0	1	0	2	5	2	8	21	~					
	CY8C4025LQI-S401	24	32	4	0	0	1	0	2	5	2	8	19		~				
	CY8C4025LQI-S402	24	32	4	0	0	1	0	2	5	2	16	27			~			
	CY8C4025AXI-S402	24	32	4	0	0	1	0	2	5	2	16	27				~		
	CY8C4025LQI-S403	24	32	4	0	0	1	0	2	5	2	16	34					~	
	CY8C4025AZI-S403	24	32	4	0	0	1	0	2	5	2	16	36						~
-	CY8C4025FNI-S412	24	32	4	0	1	1	0	2	5	2	8	21	~					
-	CY8C4025LQI-S411	24	32	4	0	1	1	0	2	5	2	8	19		~				
	CY8C4025LQI-S412	24	32	4	0	1	1	0	2	5	2	16	27			~			
	CY8C4025AXI-S412	24	32	4	0	1	1	0	2	5	2	16	27				~		
	CY8C4025LQI-S413	24	32	4	0	1	1	0	2	5	2	16	34					~	
	CY8C4025AZI-S413	24	32	4	0	1	1	0	2	5	2	16	36						~
4045	CY8C4045FNI-S412	48	32	4	0	1	1	0	2	5	2	8	21	~					
	CY8C4045LQI-S411	48	32	4	0	1	1	0	2	5	2	8	19		~				
	CY8C4045LQI-S412	48	32	4	0	1	1	0	2	5	2	16	27			~			
	CY8C4045AXI-S412	48	32	4	0	1	1	0	2	5	2	16	27				~		
	CY8C4045LQI-S413	48	32	4	0	1	1	0	2	5	2	16	34					~	
	CY8C4045AZI-S413	48	32	4	0	1	1	0	2	5	2	16	36						~

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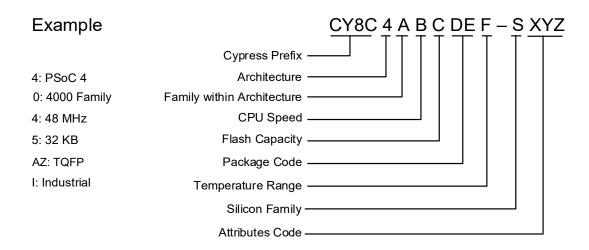


The nomenclature used in the preceding table is based on the following part numbering convention:

Table 37. Nomenclature

Field	Description	Values	Meaning
CY8C	Cypress Prefix		
4	Architecture	4	PSoC 4
Α	Family	0	4000 Family
В	CPU Speed	2	24 MHz
		4	48 MHz
С	Flash Capacity	4	16 KB
		5	32 KB
		6	64 KB
		7	128 KB
DE	Package Code	AX	TQFP (0.8-mm pitch)
		AZ	TQFP (0.5-mm pitch)
		LQ	QFN
		PV	SSOP
		FN	CSP
F	Temperature Range	I	Industrial
S	Series Designator	S	PSoC 4 S-Series
		М	PSoC 4 M-Series
		L	PSoC 4 L-Series
		BL	PSoC 4 BLE-Series
XYZ	Attributes Code	000-999	Code of feature set in the specific family

The following is an example of a part number:





# **Packaging**

The PSoC 4000S will be offered in 48-pin TQFP, 40-pin QFN, 32-pin QFN, 24-pin QFN, 32-pin TQFP, and 25-ball WLCSP packages. Package dimensions and Cypress drawing numbers are in the following table.

Table 38. Package List

Spec ID#	Package	Description	Package Dwg
BID20	48-pin TQFP	7 × 7 × 1.4 mm height with 0.5-mm pitch	51-85135
BID27	40-pin QFN	6 × 6 × 0.6 mm height with 0.5-mm pitch	001-80659
BID34A	32-pin QFN	5 × 5 × 0.6 mm height with 0.5-mm pitch	001-42168
BID34	24-pin QFN	4 × 4 × 0.6 mm height with 0.5-mm pitch	001-13937
BID34G	32-pin TQFP	7 × 7 × 1.4 mm height with 0.8-mm pitch	51-85088
BID34F	25-ball WLCSP	2.02 × 1.93 × 0.48 mm height with 0.35-mm pitch	002-09957

**Table 39. Package Thermal Characteristics** 

Parameter	Description	Package	Min	Тур	Max	Units
TA	Operating ambient temperature		-40	25	85	°C
TJ	Operating junction temperature		-40	_	100	°C
TJA	Package θ <sub>JA</sub>	48-pin TQFP	-	73.5	_	°C/W
TJC	Package θ <sub>JC</sub>	48-pin TQFP	_	33.5	_	°C/W
TJA	Package θ <sub>JA</sub>	40-pin QFN	_	17.8	_	°C/W
TJC	Package θ <sub>JC</sub>	40-pin QFN	_	2.8	_	°C/W
TJA	Package θ <sub>JA</sub>	32-pin QFN	_	20.8	_	°C/W
TJC	Package $\theta_{JC}$	32-pin QFN	_	5.9	_	°C/W
TJA	Package $\theta_{JA}$	24-pin QFN	_	21.7	-	°C/W
TJC	Package $\theta_{JC}$	24-pin QFN	_	5.6	_	°C/W
TJA	Package θ <sub>JA</sub>	32-pin TQFP	_	29.4	_	°C/W
TJC	Package $\theta_{JC}$	32-pin TQFP	_	3.5	_	°C/W
TJA	Package θ <sub>JA</sub>	25-ball WLCSP	_	54.6	_	°C/W
TJC	Package θ <sub>JC</sub>	25-ball WLCSP	-	0.5	_	°C/W

**Table 40. Solder Reflow Peak Temperature** 

Package	Maximum Peak Temperature	Maximum Time at Peak Temperature
All	260 °C	30 seconds

Table 41. Package Moisture Sensitivity Level (MSL), IPC/JEDEC J-STD-020

<del>-</del>	-
Package	MSL
All except WLCSP	MSL 3
25-ball WLCSP	MSL 1

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# **Package Diagrams**

Figure 6. 48-pin TQFP (7 × 7 × 1.4 mm) Package Outline, 51-85135

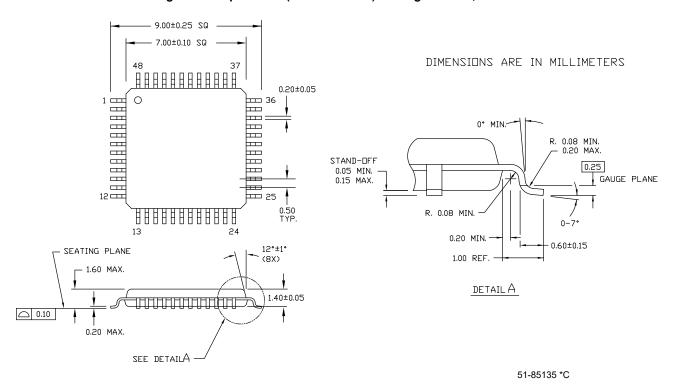
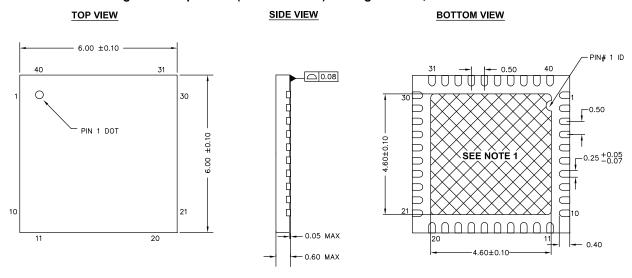


Figure 7. 40-pin QFN (6 × 6 × 0.6 mm) Package Outline, 001-80659



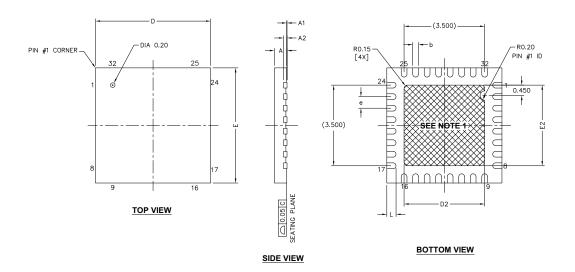
#### NOTES:

- 2. REFERENCE JEDEC # MO-248
- 3. PACKAGE WEIGHT: 68 ±2 mg
- 4. ALL DIMENSIONS ARE IN MILLIMETERS

001-80659 \*A



Figure 8. 32-pin QFN ((5.0 × 5.0 × 0.55 mm) 3.5 × 3.5 mm E-Pad (Sawn)) Package Outline, 001-42168



SYMBOL	D	IMENSIC	NS			
3 TIVIBUL	MIN.	NOM.	MAX.			
А	0.50	0.55	0.60			
A1	-	0.020	0.045			
A2	0.15 BSC					
D	4.90	5.00	5.10			
D2	3.40	3.50	3.60			
E	4.90	5.00	5.10			
E2	3.40	3.50	3.60			
L	0.30	0.40	0.50			
b	0.18	0.25	0.30			
е	0.50 TYF	)				

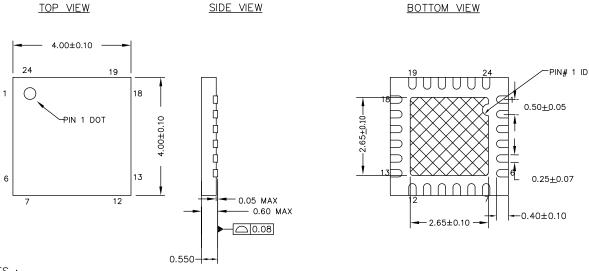
#### NOTES:

- 1. HATCH AREA IS SOLDERABLE EXPOSED PAD
- 2. BASED ON REF JEDEC # MO-248
- 3. PACKAGE WEIGHT: 0.0388g
- 4. DIMENSIONS ARE IN MILLIMETERS

001-42168 \*F



Figure 9. 24-pin QFN ((4 × 4 × 0.60 mm) 2.65 × 2.65 E-Pad (Sawn)) Package Outline, 001-13937



#### NOTES:

- 1. HATCH IS SOLDERABLE EXPOSED METAL.
- 2. REFERENCE JEDEC # MO-2483. PACKAGE WEIGHT : 29  $\pm$  3 mg
- 4. ALL DIMENSIONS ARE IN MILLIMETERS

001-13937 \*G

The center pad on the QFN package should be connected to ground (VSS) for best mechanical, thermal, and electrical performance. If not connected to ground, it should be electrically floating and not connected to any other signal.

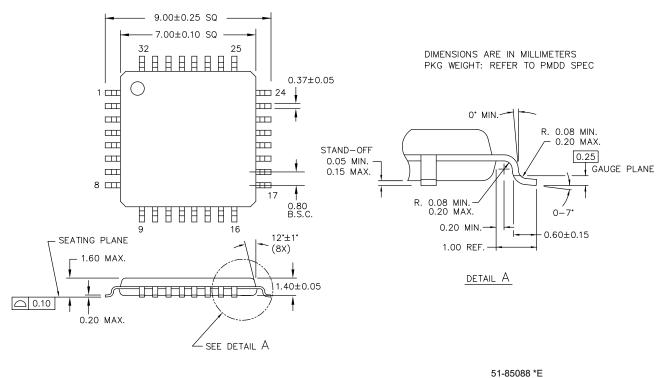


Figure 10. 32-pin TQFP (7 × 7 × 1.4 mm) Package Outline, 51-85088

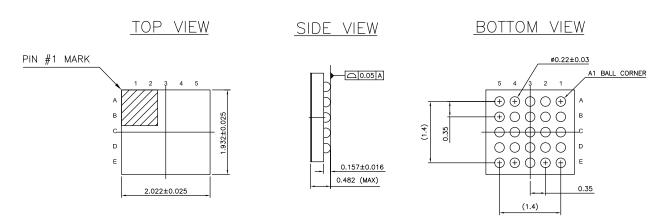


Figure 11. 25-ball WLCSP (2.02 × 1.93 × 0.48 mm) Package Outline, 002-09957

ALL DIMENSIONS ARE IN MM JEDEC Publication 95; Design Guide 4.18

002-09957 \*\*



# **Acronyms**

Table 42. Acronyms Used in this Document

Table 42. A	cronyms Used in this Document
Acronym	Description
abus	analog local bus
ADC	analog-to-digital converter
AG	analog global
AHB	AMBA (advanced microcontroller bus architecture) high-performance bus, an ARM data transfer bus
ALU	arithmetic logic unit
AMUXBUS	analog multiplexer bus
API	application programming interface
APSR	application program status register
ARM <sup>®</sup>	advanced RISC machine, a CPU architecture
ATM	automatic thump mode
BW	bandwidth
CAN	Controller Area Network, a communications protocol
CMRR	common-mode rejection ratio
CPU	central processing unit
CRC	cyclic redundancy check, an error-checking protocol
DAC	digital-to-analog converter, see also IDAC, VDAC
DFB	digital filter block
DIO	digital input/output, GPIO with only digital capabilities, no analog. See GPIO.
DMIPS	Dhrystone million instructions per second
DMA	direct memory access, see also TD
DNL	differential nonlinearity, see also INL
DNU	do not use
DR	port write data registers
DSI	digital system interconnect
DWT	data watchpoint and trace
ECC	error correcting code
ECO	external crystal oscillator
EEPROM	electrically erasable programmable read-only memory
EMI	electromagnetic interference
EMIF	external memory interface
EOC	end of conversion
EOF	end of frame
EPSR	execution program status register
ESD	electrostatic discharge

Table 42. Acronyms Used in this Document (continued)

ETM embedded trace macrocell FIR finite impulse response, see also IIR FPB flash patch and breakpoint FS full-speed GPIO general-purpose input/output, applies to a PSoC pin HVI high-voltage interrupt, see also LVI, LVD IC integrated circuit IDAC current DAC, see also DAC, VDAC IDE integrated development environment I²C, or IIC Inter-Integrated Circuit, a communications protocol IIR infinite impulse response, see also IMO IMO internal low-speed oscillator, see also IMO IMO internal main oscillator, see also ILO INL integral nonlinearity, see also DNL I/O input/output, see also GPIO, DIO, SIO, USBIO IPOR initial power-on reset IPSR interrupt program status register IRQ interrupt request ITM instrumentation trace macrocell LCD liquid crystal display LIN Local Interconnect Network, a communications protocol. LR link register LUT lookup table LVD low-voltage detect, see also LVI LVI low-voltage interrupt, see also HVI LVTTL low-voltage transistor-transistor logic MAC multiply-accumulate MCU microcontroller unit MISO master-in slave-out NC no connect NMI nonmaskable interrupt NRZ non-return-to-zero NVIC nested vectored interrupt controller NVL nonvolatile latch, see also WOL opamp operational amplifier PAL programmable array logic, see also PLD PC program counter	Acronym	Description		
FPB flash patch and breakpoint  FS full-speed  GPIO general-purpose input/output, applies to a PSoC pin  HVI high-voltage interrupt, see also LVI, LVD  IC integrated circuit  IDAC current DAC, see also DAC, VDAC  IDE integrated development environment  I <sup>2</sup> C, or IIC Inter-Integrated Circuit, a communications protocol  IIR infinite impulse response, see also FIR  ILO internal low-speed oscillator, see also IMO  IMO internal main oscillator, see also ILO  INL integral nonlinearity, see also DNL  I/O input/output, see also GPIO, DIO, SIO, USBIO  IPOR initial power-on reset  IPSR interrupt program status register  IRQ interrupt request  ITM instrumentation trace macrocell  LCD liquid crystal display  LIN Local Interconnect Network, a communications protocol.  LR link register  LUT lookup table  LVD low-voltage detect, see also LVI  LVI low-voltage interrupt, see also HVI  LVTTL low-voltage interrupt, see also HVI  LVTTL low-voltage transistor-transistor logic  MAC multiply-accumulate  MCU microcontroller unit  MISO master-in slave-out  NC no connect  NMI nonmaskable interrupt  NRZ non-return-to-zero  NVIC nested vectored interrupt controller  NVL nonvolatile latch, see also WOL  opamp operational amplifier  PAL programmable array logic, see also PLD  PC program counter	ETM	embedded trace macrocell		
FS full-speed GPIO general-purpose input/output, applies to a PSoC pin HVI high-voltage interrupt, see also LVI, LVD IC integrated circuit IDAC current DAC, see also DAC, VDAC IDE integrated development environment I²C, or IIC Inter-Integrated Circuit, a communications protocol IIR infinite impulse response, see also FIR ILO internal low-speed oscillator, see also IMO IMO internal main oscillator, see also ILO INL integral nonlinearity, see also DNL I/O input/output, see also GPIO, DIO, SIO, USBIO IPOR initial power-on reset IPSR interrupt program status register IRQ interrupt request ITM instrumentation trace macrocell LCD liquid crystal display LIN Local Interconnect Network, a communications protocol. LR link register LUT lookup table LVD low-voltage detect, see also LVI LVI low-voltage interrupt, see also HVI LVTTL low-voltage transistor-transistor logic MAC multiply-accumulate MCU microcontroller unit MISO master-in slave-out NC no connect NMI nonmaskable interrupt NRZ non-return-to-zero NVIC nested vectored interrupt controller NVL nonvolatile latch, see also WOL opamp operational amplifier PAL programmable array logic, see also PLD PC program counter	FIR	finite impulse response, see also IIR		
GPIO general-purpose input/output, applies to a PSoC pin  HVI high-voltage interrupt, see also LVI, LVD  IC integrated circuit  IDAC current DAC, see also DAC, VDAC  IDE integrated development environment  I <sup>2</sup> C, or IIC Inter-Integrated Circuit, a communications protocol  IIR infinite impulse response, see also FIR  ILO internal low-speed oscillator, see also IMO  IMO internal main oscillator, see also ILO  INL integral nonlinearity, see also DNL  I/O input/output, see also GPIO, DIO, SIO, USBIO  IPOR initial power-on reset  IPSR interrupt program status register  IRQ interrupt request  ITM instrumentation trace macrocell  LCD liquid crystal display  LIN Local Interconnect Network, a communications protocol.  LR link register  LUT lookup table  LVD low-voltage detect, see also LVI  LVI low-voltage interrupt, see also HVI  LVTTL low-voltage transistor-transistor logic  MAC multiply-accumulate  MCU microcontroller unit  MISO master-in slave-out  NC no connect  NMI nonmaskable interrupt  NRZ non-return-to-zero  NVIC nested vectored interrupt controller  NVL nonvolatile latch, see also WOL  opamp operational amplifier  PAL programmable array logic, see also PLD  PC program counter	FPB	flash patch and breakpoint		
hVI high-voltage interrupt, see also LVI, LVD  IC integrated circuit  IDAC current DAC, see also DAC, VDAC  IDE integrated development environment  I²C, or IIC Inter-Integrated Circuit, a communications protocol  IIR infinite impulse response, see also FIR  ILO internal low-speed oscillator, see also IMO  IMO internal main oscillator, see also ILO  INL integral nonlinearity, see also DNL  I/O input/output, see also GPIO, DIO, SIO, USBIO  IPOR initial power-on reset  IPSR interrupt program status register  IRQ interrupt request  ITM instrumentation trace macrocell  LCD liquid crystal display  LIN Local Interconnect Network, a communications protocol.  LR link register  LUT lookup table  LVD low-voltage detect, see also LVI  LVI low-voltage interrupt, see also HVI  LVTTL low-voltage transistor-transistor logic  MAC multiply-accumulate  MCU microcontroller unit  MISO master-in slave-out  NC no connect  NMI nonmaskable interrupt  NRZ non-return-to-zero  NVIC nested vectored interrupt controller  NVL nonvolatile latch, see also WOL  opamp operational amplifier  PAL programmable array logic, see also PLD  PC program counter	FS	full-speed		
IC integrated circuit  IDAC current DAC, see also DAC, VDAC  IDE integrated development environment  I <sup>2</sup> C, or IIC Inter-Integrated Circuit, a communications protocol  IIR infinite impulse response, see also FIR  ILO internal low-speed oscillator, see also IMO  IMO internal main oscillator, see also ILO  INL integral nonlinearity, see also DNL  I/O input/output, see also GPIO, DIO, SIO, USBIO  IPOR initial power-on reset  IPSR interrupt program status register  IRQ interrupt request  ITM instrumentation trace macrocell  LCD liquid crystal display  LIN Local Interconnect Network, a communications protocol.  LR link register  LUT lookup table  LVD low-voltage detect, see also LVI  LVI low-voltage interrupt, see also HVI  LVTTL low-voltage transistor-transistor logic  MAC multiply-accumulate  MCU microcontroller unit  MISO master-in slave-out  NC no connect  NMI nonmaskable interrupt  NRZ non-return-to-zero  NVIC nested vectored interrupt controller  NVL nonvolatile latch, see also WOL  opamp operational amplifier  PAL programmable array logic, see also PLD  PC program counter	GPIO	17.		
IDAC current DAC, see also DAC, VDAC  IDE integrated development environment  I <sup>2</sup> C, or IIC Inter-Integrated Circuit, a communications protocol  IIR infinite impulse response, see also FIR  ILO internal low-speed oscillator, see also IMO  IMO internal main oscillator, see also ILO  INL integral nonlinearity, see also DNL  I/O input/output, see also GPIO, DIO, SIO, USBIO  IPOR initial power-on reset  IPSR interrupt program status register  IRQ interrupt request  ITM instrumentation trace macrocell  LCD liquid crystal display  LIN Local Interconnect Network, a communications protocol.  LR link register  LUT lookup table  LVD low-voltage detect, see also LVI  LVI low-voltage interrupt, see also HVI  LVTTL low-voltage transistor-transistor logic  MAC multiply-accumulate  MCU microcontroller unit  MISO master-in slave-out  NC no connect  NMI nonmaskable interrupt  NRZ non-return-to-zero  NVIC nested vectored interrupt controller  NVL nonvolatile latch, see also WOL  opamp operational amplifier  PAL programmable array logic, see also PLD  PC program counter	HVI	high-voltage interrupt, see also LVI, LVD		
IDE integrated development environment  I <sup>2</sup> C, or IIC Inter-Integrated Circuit, a communications protocol  IIR infinite impulse response, see also FIR  ILO internal low-speed oscillator, see also IMO  IMO internal main oscillator, see also ILO  INL integral nonlinearity, see also DNL  I/O input/output, see also GPIO, DIO, SIO, USBIO  IPOR initial power-on reset  IPSR interrupt program status register  IRQ interrupt request  ITM instrumentation trace macrocell  LCD liquid crystal display  LIN Local Interconnect Network, a communications protocol.  LR link register  LUT lookup table  LVD low-voltage detect, see also LVI  LVI low-voltage interrupt, see also HVI  LVTTL low-voltage transistor-transistor logic  MAC multiply-accumulate  MCU microcontroller unit  MISO master-in slave-out  NC no connect  NMI nonmaskable interrupt  NRZ non-return-to-zero  NVIC nested vectored interrupt controller  NVL nonvolatile latch, see also WOL  opamp operational amplifier  PAL programmable array logic, see also PLD  PC program counter	IC	integrated circuit		
I <sup>2</sup> C, or IIC Inter-Integrated Circuit, a communications protocol  IIR infinite impulse response, see also FIR  ILO internal low-speed oscillator, see also IMO  IMO internal main oscillator, see also ILO  INL integral nonlinearity, see also DNL  I/O input/output, see also GPIO, DIO, SIO, USBIO  IPOR initial power-on reset  IPSR interrupt program status register  IRQ interrupt request  ITM instrumentation trace macrocell  LCD liquid crystal display  LIN Local Interconnect Network, a communications protocol.  LR link register  LUT lookup table  LVD low-voltage detect, see also LVI  LVI low-voltage interrupt, see also HVI  LVTTL low-voltage transistor-transistor logic  MAC multiply-accumulate  MCU microcontroller unit  MISO master-in slave-out  NC no connect  NMI nonmaskable interrupt  NRZ non-return-to-zero  NVIC nested vectored interrupt controller  NVL nonvolatile latch, see also WOL  opamp operational amplifier  PAL programmable array logic, see also PLD  PC program counter	IDAC	current DAC, see also DAC, VDAC		
IIR infinite impulse response, see also FIR ILO internal low-speed oscillator, see also IMO IMO internal main oscillator, see also ILO INL integral nonlinearity, see also DNL I/O input/output, see also GPIO, DIO, SIO, USBIO IPOR initial power-on reset IPSR interrupt program status register IRQ interrupt request ITM instrumentation trace macrocell LCD liquid crystal display LIN Local Interconnect Network, a communications protocol. LR link register LUT lookup table LVD low-voltage detect, see also LVI LVI low-voltage interrupt, see also HVI LVTTL low-voltage transistor-transistor logic MAC multiply-accumulate MCU microcontroller unit MISO master-in slave-out NC no connect NMI nonmaskable interrupt NRZ non-return-to-zero NVIC nested vectored interrupt controller NVL nonvolatile latch, see also WOL opamp operational amplifier PAL programmable array logic, see also PLD PC program counter	IDE	integrated development environment		
ILO internal low-speed oscillator, see also IMO internal main oscillator, see also ILO INL integral nonlinearity, see also DNL i/O input/output, see also GPIO, DIO, SIO, USBIO IPOR initial power-on reset IPSR interrupt program status register IRQ interrupt request ITM instrumentation trace macrocell IcD Iquid crystal display LOCAL Interconnect Network, a communications protocol.  LR link register LUT lookup table LVD low-voltage detect, see also LVI LVI low-voltage interrupt, see also HVI LVTTL low-voltage transistor-transistor logic MAC multiply-accumulate MCU microcontroller unit MISO master-in slave-out NC no connect NMI nonmaskable interrupt NRZ non-return-to-zero NVIC nested vectored interrupt controller NVL nonvolatile latch, see also WOL opamp operational amplifier PAL programmable array logic, see also PLD PC program counter	I <sup>2</sup> C, or IIC			
IMO internal main oscillator, see also ILO INL integral nonlinearity, see also DNL I/O input/output, see also GPIO, DIO, SIO, USBIO IPOR initial power-on reset IPSR interrupt program status register IRQ interrupt request ITM instrumentation trace macrocell LCD liquid crystal display LIN Local Interconnect Network, a communications protocol. LR link register LUT lookup table LVD low-voltage detect, see also LVI LVI low-voltage interrupt, see also HVI LVTTL low-voltage transistor-transistor logic MAC multiply-accumulate MCU microcontroller unit MISO master-in slave-out NC no connect NMI nonmaskable interrupt NRZ non-return-to-zero NVIC nested vectored interrupt controller NVL nonvolatile latch, see also WOL opamp operational amplifier PAL programmable array logic, see also PLD PC program counter	IIR	infinite impulse response, see also FIR		
INL integral nonlinearity, see also DNL I/O input/output, see also GPIO, DIO, SIO, USBIO IPOR initial power-on reset IPSR interrupt program status register IRQ interrupt request ITM instrumentation trace macrocell LCD liquid crystal display LIN Local Interconnect Network, a communications protocol. LR link register LUT lookup table LVD low-voltage detect, see also LVI LVI low-voltage interrupt, see also HVI LVTTL low-voltage transistor-transistor logic MAC multiply-accumulate MCU microcontroller unit MISO master-in slave-out NC no connect NMI nonmaskable interrupt NRZ non-return-to-zero NVIC nested vectored interrupt controller NVL nonvolatile latch, see also WOL opamp operational amplifier PAL programmable array logic, see also PLD PC program counter	ILO	internal low-speed oscillator, see also IMO		
I/O input/output, see also GPIO, DIO, SIO, USBIO IPOR initial power-on reset IPSR interrupt program status register IRQ interrupt request ITM instrumentation trace macrocell LCD liquid crystal display LIN Local Interconnect Network, a communications protocol. LR link register LUT lookup table LVD low-voltage detect, see also LVI LVI low-voltage interrupt, see also HVI LVTTL low-voltage transistor-transistor logic MAC multiply-accumulate MCU microcontroller unit MISO master-in slave-out NC no connect NMI nonmaskable interrupt NRZ non-return-to-zero NVIC nested vectored interrupt controller NVL nonvolatile latch, see also WOL opamp operational amplifier PAL programmable array logic, see also PLD PC program counter	IMO	internal main oscillator, see also ILO		
IPOR initial power-on reset IPSR interrupt program status register IRQ interrupt request ITM instrumentation trace macrocell LCD liquid crystal display LIN Local Interconnect Network, a communications protocol. LR link register LUT lookup table LVD low-voltage detect, see also LVI LVI low-voltage interrupt, see also HVI LVTTL low-voltage transistor-transistor logic MAC multiply-accumulate MCU microcontroller unit MISO master-in slave-out NC no connect NMI nonmaskable interrupt NRZ non-return-to-zero NVIC nested vectored interrupt controller NVL nonvolatile latch, see also WOL opamp operational amplifier PAL programmable array logic, see also PLD PC program counter	INL	integral nonlinearity, see also DNL		
IPSR interrupt program status register IRQ interrupt request ITM instrumentation trace macrocell LCD liquid crystal display LIN Local Interconnect Network, a communications protocol. LR link register LUT lookup table LVD low-voltage detect, see also LVI LVI low-voltage interrupt, see also HVI LVTTL low-voltage transistor-transistor logic MAC multiply-accumulate MCU microcontroller unit MISO master-in slave-out NC no connect NMI nonmaskable interrupt NRZ non-return-to-zero NVIC nested vectored interrupt controller NVL nonvolatile latch, see also WOL opamp operational amplifier PAL programmable array logic, see also PLD PC program counter	I/O	input/output, see also GPIO, DIO, SIO, USBIO		
IRQ interrupt request ITM instrumentation trace macrocell LCD liquid crystal display LIN Local Interconnect Network, a communications protocol. LR link register LUT lookup table LVD low-voltage detect, see also LVI LVI low-voltage interrupt, see also HVI LVTTL low-voltage transistor-transistor logic MAC multiply-accumulate MCU microcontroller unit MISO master-in slave-out NC no connect NMI nonmaskable interrupt NRZ non-return-to-zero NVIC nested vectored interrupt controller NVL nonvolatile latch, see also WOL opamp operational amplifier PAL programmable array logic, see also PLD PC program counter	IPOR	initial power-on reset		
ITM instrumentation trace macrocell  LCD liquid crystal display  LIN Local Interconnect Network, a communications protocol.  LR link register  LUT lookup table  LVD low-voltage detect, see also LVI  LVI low-voltage interrupt, see also HVI  LVTTL low-voltage transistor-transistor logic  MAC multiply-accumulate  MCU microcontroller unit  MISO master-in slave-out  NC no connect  NMI nonmaskable interrupt  NRZ non-return-to-zero  NVIC nested vectored interrupt controller  NVL nonvolatile latch, see also WOL  opamp operational amplifier  PAL programmable array logic, see also PLD  PC program counter	IPSR	interrupt program status register		
LCD liquid crystal display  LIN Local Interconnect Network, a communications protocol.  LR link register  LUT lookup table  LVD low-voltage detect, see also LVI  LVI low-voltage interrupt, see also HVI  LVTTL low-voltage transistor-transistor logic  MAC multiply-accumulate  MCU microcontroller unit  MISO master-in slave-out  NC no connect  NMI nonmaskable interrupt  NRZ non-return-to-zero  NVIC nested vectored interrupt controller  NVL nonvolatile latch, see also WOL  opamp operational amplifier  PAL programmable array logic, see also PLD  PC program counter	IRQ	interrupt request		
LIN Local Interconnect Network, a communications protocol.  LR link register  LUT lookup table  LVD low-voltage detect, see also LVI  LVI low-voltage interrupt, see also HVI  LVTTL low-voltage transistor-transistor logic  MAC multiply-accumulate  MCU microcontroller unit  MISO master-in slave-out  NC no connect  NMI nonmaskable interrupt  NRZ non-return-to-zero  NVIC nested vectored interrupt controller  NVL nonvolatile latch, see also WOL  opamp operational amplifier  PAL programmable array logic, see also PLD  PC program counter	ITM	instrumentation trace macrocell		
protocol.  LR link register  LUT lookup table  LVD low-voltage detect, see also LVI  LVI low-voltage interrupt, see also HVI  LVTTL low-voltage transistor-transistor logic  MAC multiply-accumulate  MCU microcontroller unit  MISO master-in slave-out  NC no connect  NMI nonmaskable interrupt  NRZ non-return-to-zero  NVIC nested vectored interrupt controller  NVL nonvolatile latch, see also WOL  opamp operational amplifier  PAL programmable array logic, see also PLD  PC program counter	LCD	liquid crystal display		
LUT lookup table  LVD low-voltage detect, see also LVI  LVI low-voltage interrupt, see also HVI  LVTTL low-voltage transistor-transistor logic  MAC multiply-accumulate  MCU microcontroller unit  MISO master-in slave-out  NC no connect  NMI nonmaskable interrupt  NRZ non-return-to-zero  NVIC nested vectored interrupt controller  NVL nonvolatile latch, see also WOL  opamp operational amplifier  PAL programmable array logic, see also PLD  PC program counter	LIN			
LVD low-voltage detect, see also LVI LVI low-voltage interrupt, see also HVI LVTTL low-voltage transistor-transistor logic MAC multiply-accumulate MCU microcontroller unit MISO master-in slave-out NC no connect NMI nonmaskable interrupt NRZ non-return-to-zero NVIC nested vectored interrupt controller NVL nonvolatile latch, see also WOL opamp operational amplifier PAL programmable array logic, see also PLD PC program counter	LR	link register		
LVI low-voltage interrupt, see also HVI LVTTL low-voltage transistor-transistor logic MAC multiply-accumulate MCU microcontroller unit MISO master-in slave-out NC no connect NMI nonmaskable interrupt NRZ non-return-to-zero NVIC nested vectored interrupt controller NVL nonvolatile latch, see also WOL opamp operational amplifier PAL programmable array logic, see also PLD PC program counter	LUT	lookup table		
LVTTL low-voltage transistor-transistor logic  MAC multiply-accumulate  MCU microcontroller unit  MISO master-in slave-out  NC no connect  NMI nonmaskable interrupt  NRZ non-return-to-zero  NVIC nested vectored interrupt controller  NVL nonvolatile latch, see also WOL  opamp operational amplifier  PAL programmable array logic, see also PLD  PC program counter	LVD	low-voltage detect, see also LVI		
MAC multiply-accumulate  MCU microcontroller unit  MISO master-in slave-out  NC no connect  NMI nonmaskable interrupt  NRZ non-return-to-zero  NVIC nested vectored interrupt controller  NVL nonvolatile latch, see also WOL  opamp operational amplifier  PAL programmable array logic, see also PLD  PC program counter	LVI	low-voltage interrupt, see also HVI		
MCU microcontroller unit  MISO master-in slave-out  NC no connect  NMI nonmaskable interrupt  NRZ non-return-to-zero  NVIC nested vectored interrupt controller  NVL nonvolatile latch, see also WOL  opamp operational amplifier  PAL programmable array logic, see also PLD  PC program counter	LVTTL	low-voltage transistor-transistor logic		
MISO master-in slave-out  NC no connect  NMI nonmaskable interrupt  NRZ non-return-to-zero  NVIC nested vectored interrupt controller  NVL nonvolatile latch, see also WOL  opamp operational amplifier  PAL programmable array logic, see also PLD  PC program counter	MAC	multiply-accumulate		
NC no connect  NMI nonmaskable interrupt  NRZ non-return-to-zero  NVIC nested vectored interrupt controller  NVL nonvolatile latch, see also WOL  opamp operational amplifier  PAL programmable array logic, see also PLD  PC program counter	MCU	microcontroller unit		
NMI nonmaskable interrupt  NRZ non-return-to-zero  NVIC nested vectored interrupt controller  NVL nonvolatile latch, see also WOL  opamp operational amplifier  PAL programmable array logic, see also PLD  PC program counter	MISO	master-in slave-out		
NRZ non-return-to-zero  NVIC nested vectored interrupt controller  NVL nonvolatile latch, see also WOL  opamp operational amplifier  PAL programmable array logic, see also PLD  PC program counter	NC	no connect		
NVIC nested vectored interrupt controller  NVL nonvolatile latch, see also WOL  opamp operational amplifier  PAL programmable array logic, see also PLD  PC program counter	NMI	nonmaskable interrupt		
NVL nonvolatile latch, see also WOL opamp operational amplifier PAL programmable array logic, see also PLD PC program counter	NRZ	non-return-to-zero		
opamp operational amplifier  PAL programmable array logic, see also PLD  PC program counter	NVIC	nested vectored interrupt controller		
PAL programmable array logic, see also PLD PC program counter	NVL	nonvolatile latch, see also WOL		
PC program counter	opamp	operational amplifier		
1 3	PAL	programmable array logic, see also PLD		
PCB printed circuit board	PC			
	PCB	<u> </u>		

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Table 42. Acronyms Used in this Document (continued)

Acronym	Description	
PGA	programmable gain amplifier	
PHUB	peripheral hub	
PHY	physical layer	
PICU	port interrupt control unit	
PLA	programmable logic array	
PLD	programmable logic device, see also PAL	
PLL	phase-locked loop	
PMDD	package material declaration data sheet	
POR	power-on reset	
PRES	precise power-on reset	
PRS	pseudo random sequence	
PS	port read data register	
PSoC <sup>®</sup>	Programmable System-on-Chip™	
PSRR	power supply rejection ratio	
PWM	pulse-width modulator	
RAM	random-access memory	
RISC	reduced-instruction-set computing	
RMS	root-mean-square	
RTC	real-time clock	
RTL	register transfer language	
RTR	remote transmission request	
RX	receive	
SAR	successive approximation register	
SC/CT	switched capacitor/continuous time	
SCL	I <sup>2</sup> C serial clock	
SDA	I <sup>2</sup> C serial data	
S/H	sample and hold	
SINAD	signal to noise and distortion ratio	
SIO	special input/output, GPIO with advanced features. See GPIO.	
SOC	start of conversion	
SOF	start of frame	
SPI	Serial Peripheral Interface, a communications protocol	
SR	slew rate	
SRAM	static random access memory	
SRES	software reset	
SWD	serial wire debug, a test protocol	
SWV	single-wire viewer	
TD	transaction descriptor, see also DMA	

Table 42. Acronyms Used in this Document (continued)

Acronym	Description
THD	total harmonic distortion
TIA	transimpedance amplifier
TRM	technical reference manual
TTL	transistor-transistor logic
TX	transmit
UART	Universal Asynchronous Transmitter Receiver, a communications protocol
UDB	universal digital block
USB	Universal Serial Bus
USBIO	USB input/output, PSoC pins used to connect to a USB port
VDAC	voltage DAC, see also DAC, IDAC
WDT	watchdog timer
WOL	write once latch, see also NVL
WRES	watchdog timer reset
XRES	external reset I/O pin
XTAL	crystal

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# **Document Conventions**

# **Units of Measure**

# Table 43. Units of Measure

Symbol	Units of Measure  Unit of Measure	
°C	degrees Celsius	
dB	decibel	
fF	femto farad	
Hz	hertz	
KB	1024 bytes	
kbps	kilobits per second	
Khr	kilohour	
kHz	kilohertz	
kΩ	kilo ohm	
ksps	kilosamples per second	
LSB	least significant bit	
	-	
Mbps MHz	megabits per second	
	megahertz	
ΜΩ	mega-ohm	
Msps	megasamples per second	
μA	microampere	
μF	microfarad	
μH	microhenry	
μs	microsecond	
μV	microvolt	
μW	microwatt	
mA	milliampere	
ms	millisecond	
mV	millivolt	
nA	nanoampere	
ns	nanosecond	
nV	nanovolt	
Ω	ohm	
pF	picofarad	
ppm	parts per million	
ps	picosecond	
s	second	
sps	samples per second	
sqrtHz	square root of hertz	
V	volt	

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# **Document History Page**

Revision	ECN	Submission Date	Description of Change
**	4883809	08/28/2015	New data sheet.
*A	4992376	10/30/2015	Removed 20-ball WLCSP package related information in all instances across the document Added 25-ball WLCSP package related information in all instances across the document. Updated Pinouts: Updated Table 1. Updated Table 1. Updated Electrical Specifications: Updated Analog Peripherals: Updated Comparator: Updated Table 10 (Updated details in "Details/Conditions" column corresponding to $V_{ICM3}$ , $I_{CMP3}$ parameters (Added $V_{DDD} \ge 2.2V$ at $-40$ °C)). Updated Table 11 (Updated details in "Details/Conditions" column corresponding to TRESP3 parameter (Added $V_{DDD} \ge 2.2V$ at $-40$ °C)). Updated CSD and IDAC: Updated Table 13. Updated Ordering Information: Updated part numbers.
*B	5037826	12/08/2015	Changed status from Advance to Preliminary.
*C	5104369	01/27/2016	Updated Packaging: Updated Table 39 (Replaced TBD with values for Theta J <sub>A</sub> and Theta J <sub>C</sub> parameters). Updated Package Diagrams: Replaced TBD with spec 002-09957 **. Added Errata.
*D	5139206	02/16/2016	Updated to new template.
*E	5173961	03/15/2016	Updated Pinouts: Updated Table 1. Updated Electrical Specifications: Updated Device Level Specifications: Updated XRES: Updated Table 8 (Updated all values corresponding to R <sub>PULLUP</sub> parameter). Updated Table 9 (Updated all values corresponding to T <sub>RESETWAKE</sub> parameter). Updated Analog Peripherals: Updated CSD and IDAC: Updated Table 12. Updated Table 12. Updated Table 13. Updated Table 13. Updated Memory: Updated Flash: Updated Table 24 (Updated all values corresponding to T <sub>ROWERASE</sub> , T <sub>ROWPROGRAM</sub> parameters).
*F	5268662	05/12/2016	Updated Pinouts: Updated Alternate Pin Functions: Updated Table 2. Updated Electrical Specifications: Updated Analog Peripherals: Updated CSD and IDAC: Updated Table 12 (Updated all values corresponding to IDAC1INL, IDAC2INL, SNR, IDAC1CRT1, IDAC1CRT12, IDAC1CRT22, IDAC1CRT32, IDAC2CRT11, IDAC2CRT12, IDAC2CRT22, IDAC3, IDAC3, IDAC3, IDAC3, IDAC3, IDAC4, IDAC4, IDAC4, IDAC4, IDAC5, IDA



# **Document History Page** (continued)

Descriptio Document	n Title: PSo Number: 0	C <sup>®</sup> 4: PSoC 40 02-00123	000S Datasheet, Programmable System-on-Chip (PSoC <sup>®</sup> )
Revision	ECN	Submission Date	Description of Change
*G	5330930	07/27/2016	Changed status from Preliminary to Final.  Updated Functional Overview: Updated Special Function Peripherals: Updated LCD Segment Drive: Updated description.  Updated Electrical Specifications: Updated Device Level Specifications: Updated Table 4 (Updated details corresponding to I <sub>DD5</sub> , I <sub>DD8</sub> , I <sub>DD11</sub> , I <sub>DD17</sub> , I <sub>DD20</sub> , I <sub>DD23</sub> , I <sub>DD23</sub> , I <sub>DD23</sub> , I <sub>DD29</sub> , I <sub>DD2</sub>
*H	5415365	09/14/2016	Added 40-pin QFN package related information in all instances across the document. Updated Electrical Specifications: Updated Device Level Specifications: Updated Table 4 (Updated details corresponding to I <sub>DD5</sub> , I <sub>DD8</sub> , I <sub>DD11</sub> , I <sub>DD17</sub> , I <sub>DD20</sub> , I <sub>DD23</sub> , I <sub>DD23A</sub> , I <sub>DD26</sub> , I <sub>DD29</sub> , I <sub>DD27</sub> , I <sub>DD27</sub> , I <sub>DD28</sub>
*	5561833	01/09/2017	Updated Electrical Specifications: Replaced PRGIO with Smart I/O in all instances.
*J	5704046	04/26/2017	Updated the Cypress Logo and Copyright.
*K	5969745	11/17/2017	Updated Document Title to read as "PSoC® 4: PSoC 4000S Datasheet Programmable System-on-Chip (PSoC®)".  Added 32-pin TQFP Package related information in all instance across the document. Updated Ordering Information: Updated part numbers. Updated Packaging: Updated Package Diagrams: spec 001-42168 – Changed revision from *E to *F. Added spec 51-85088 *E.
*L	6639191	07/31/2019	Updated Features: Updated 32-bit MCU Subsystem: Updated description. Added More Information. Added PSoC Creator. Updated Functional Overview: Updated System Resources: Updated Power System: Updated description. Updated Watch Crystal Oscillator (WCO): Updated description. Updated Fixed Function Digital: Updated Serial Communication Block (SCB): Updated description. Updated Special Function Peripherals: Updated LCD Segment Drive: Updated description.



# **Document History Page** (continued)

Revision	ECN	Submission Date	Description of Change
*L (cont.)	6639191	07/31/2019	Updated Pinouts: Added Note below Table 1. Updated Electrical Specifications: Updated Analog Peripherals: Updated CSD and IDAC: Updated Table 12 (Updated details in "Details/Conditions" column corresponding to V <sub>REF</sub> Updated Digital Peripherals: Updated Digital Peripherals: Updated SPI: Updated Table 18 (Updated all values corresponding to TSSELSSCK parameter). Updated Ordering Information: Updated Packaging: Updated Package Diagrams: spec 001-13937 – Changed revision from *F to *G. Updated to new template. Completing Sunset Review.



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